



U.S. Particle Accelerator School

Education in Beam Physics and Accelerator Technology

Simulations of Beam and Plasma Systems

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Mesh Refinement in Field Solvers

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U.S. DEPARTMENT OF
ENERGY

Office of Science



EXASCALE
COMPUTING
PROJECT



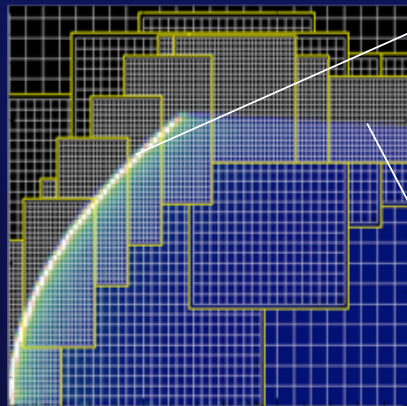
Outline

- Why mesh refinement?
- Potential issues
- Electrostatic mesh refinement
 - spurious self-force example
 - spurious self-force mitigation
 - application to the modeling of HCX injector
- Electromagnetic mesh refinement
 - spurious reflection of waves
 - spurious reflection of waves mitigation
 - Application to the modeling beam-induced plasma wake
- Special mesh refinement for particle emission
- Summary

Why mesh refinement?

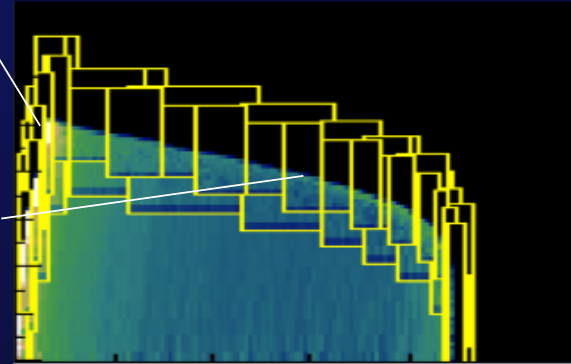
To resolve density spikes & gradients.

Injector

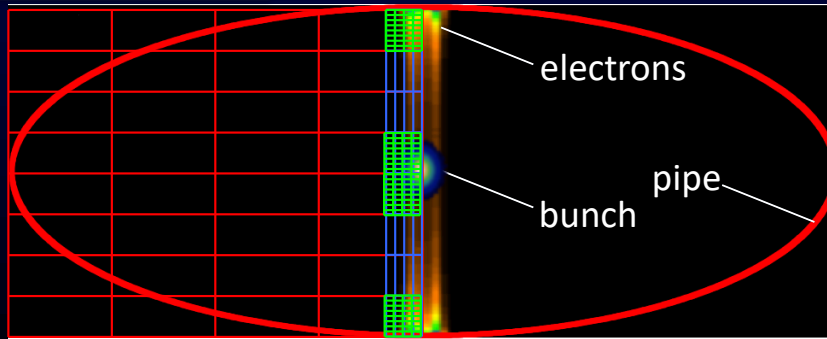


emitter

Beam edge



Electron cloud

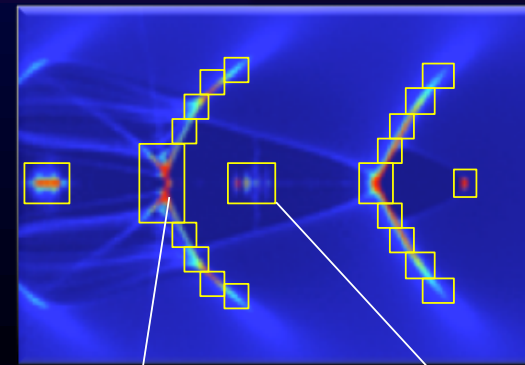


electrons

bunch

pipe

Plasma accelerator



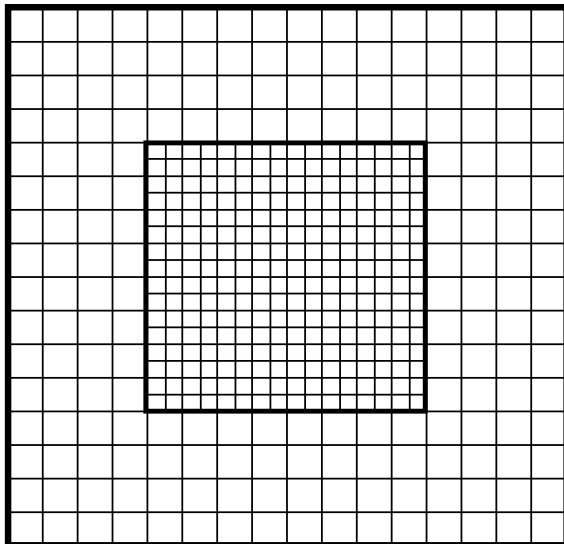
Electron density spikes

Small electron beams

Coupling of AMR to PIC: issues

Mesh refinement implies:

- jump of resolution at coarse-fine interface,
- some procedure for coupling the solutions at the interface.

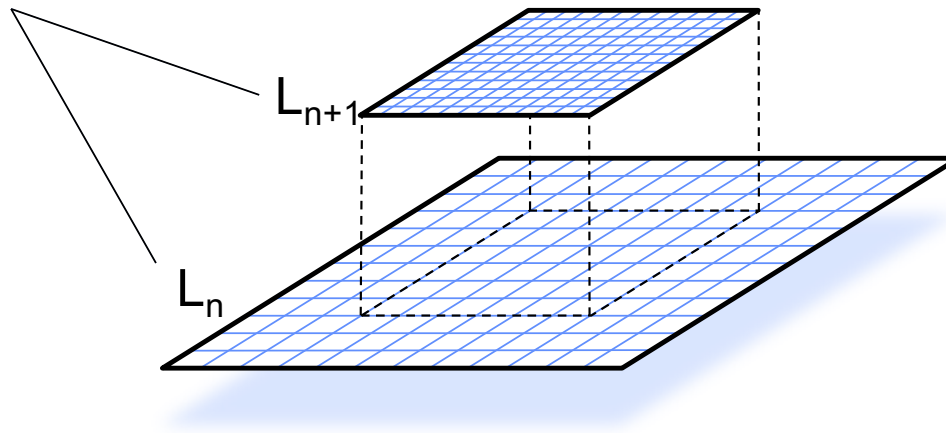


Consequences:

- loss of symmetry: self-force,
- loss of conservation laws,
- EM: waves reflection.

Electrostatic mesh refinement

Refinement levels



Solution to Poisson is a boundary value problem.

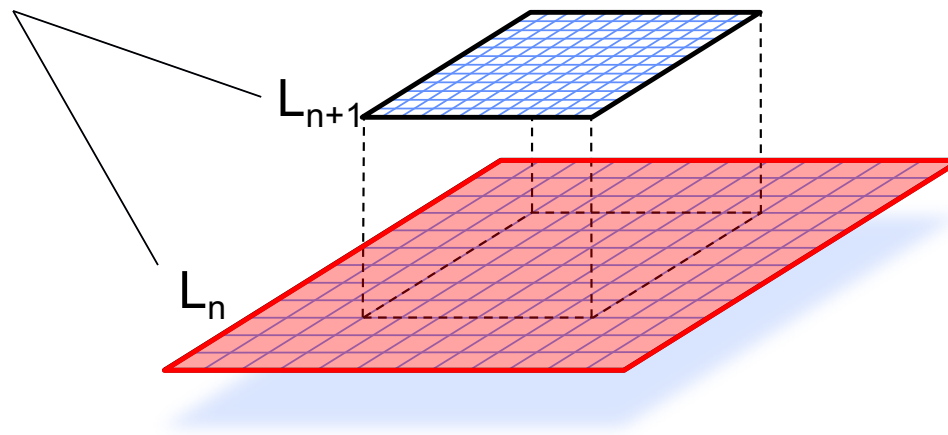
We can define the following simple procedure:

1. solve on coarse grid,
2. interpolate on fine grid boundaries,
3. solve on fine grid.



Electrostatic mesh refinement

Refinement levels



Solution to Poisson is a boundary value problem.

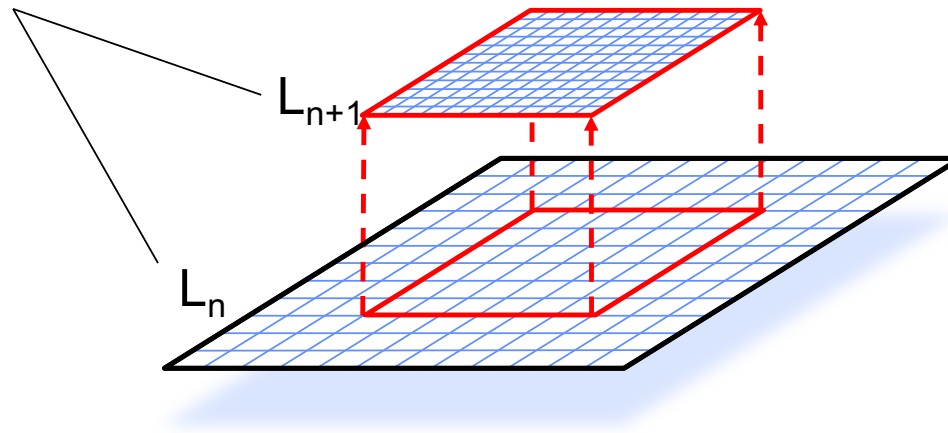
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Electrostatic mesh refinement

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Solution to Poisson is a boundary value problem.

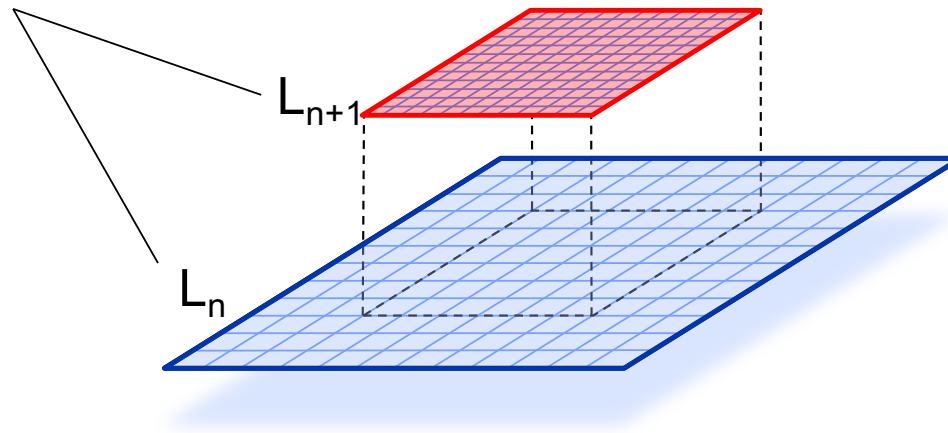
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Electrostatic mesh refinement

Refinement levels



Solution to Poisson is a boundary value problem.

We can define the following simple procedure:

1. solve on coarse grid,
2. interpolate on fine grid boundaries,
3. **solve on fine grid.**



Illustration potential problem: spurious self-force

Test using script `test1partin1patch.py`:

- Run with `l_mr=0`.

One charged macroparticle
in a box with metallic BC

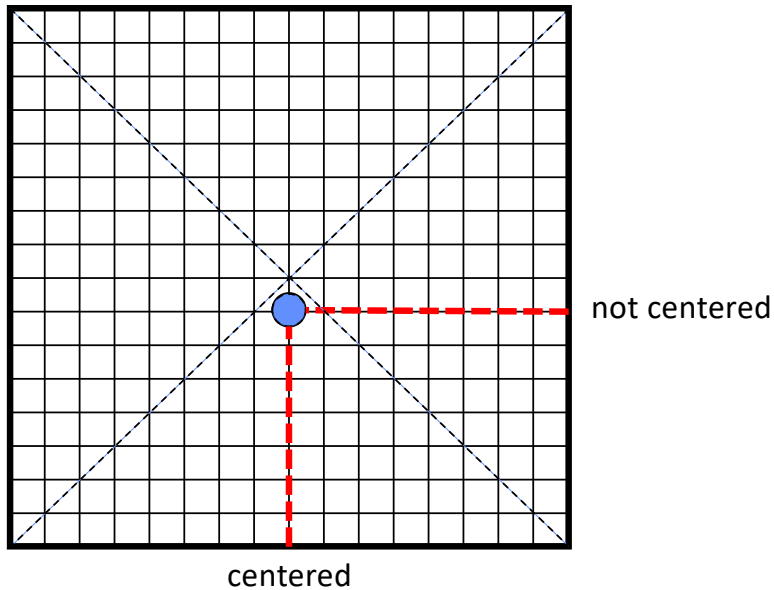


Illustration potential problem: spurious self-force

Test using script `test1partin1patch.py`:

- Run with `l_mr=0`.

The macroparticle is attracted by its image from the closest metallic wall.

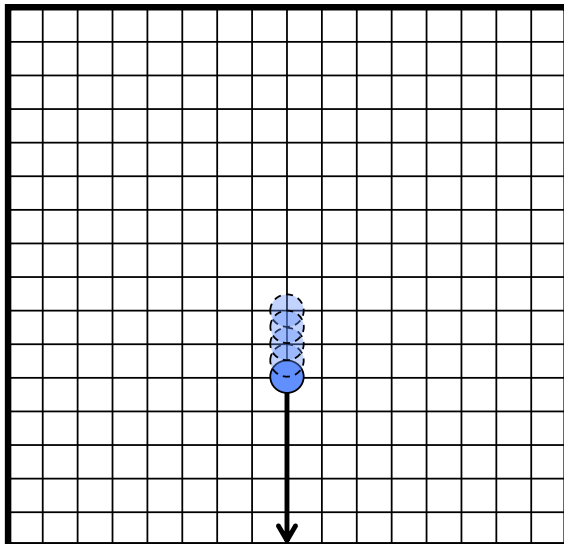


Illustration potential problem: spurious self-force

Test using script `test1partin1patch.py`:

- Run with `l_mr=0`.

We apply specular reflection at the boundary.

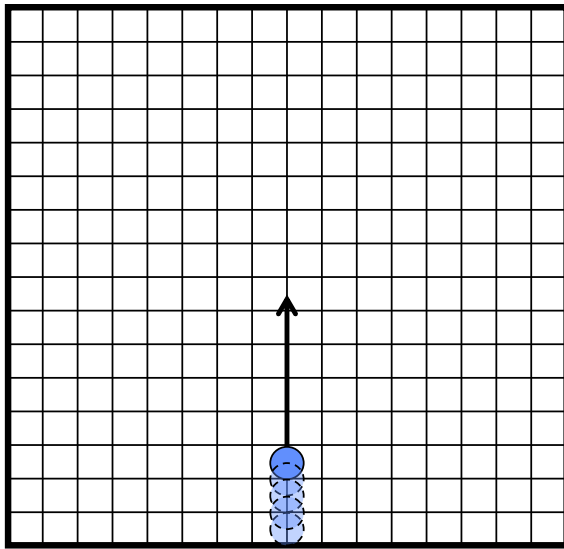


Illustration potential problem: spurious self-force

Test using script test1partin1patch.py:

- Run with $l_{mr}=0$.

The particle moves up and down.

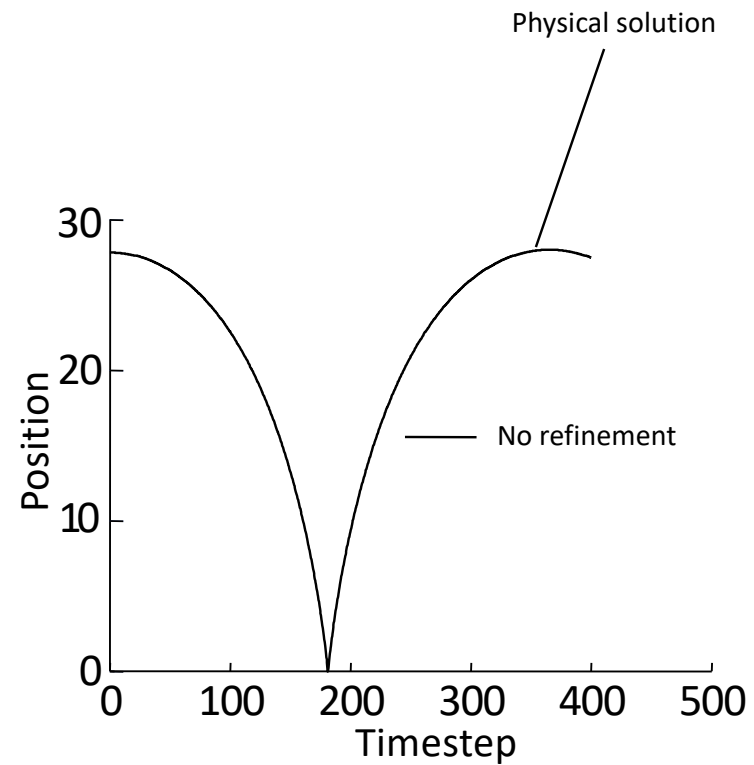
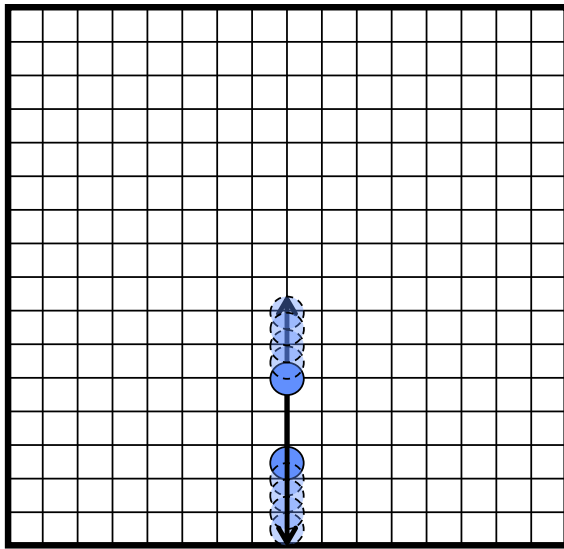


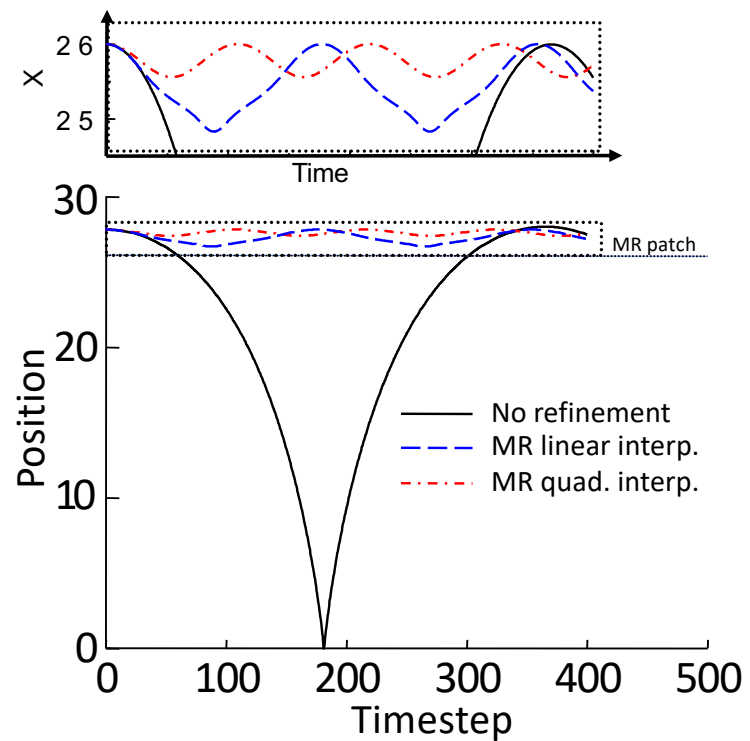
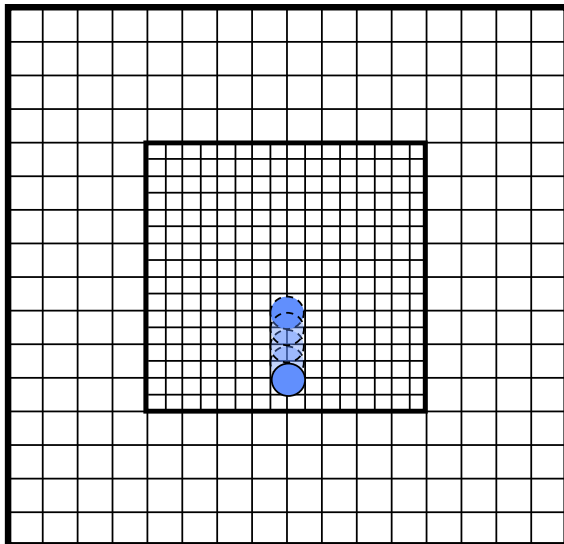
Illustration potential problem: spurious self-force

Test using script `test1partin1patch.py`:

- Run with `l_mr=1`.

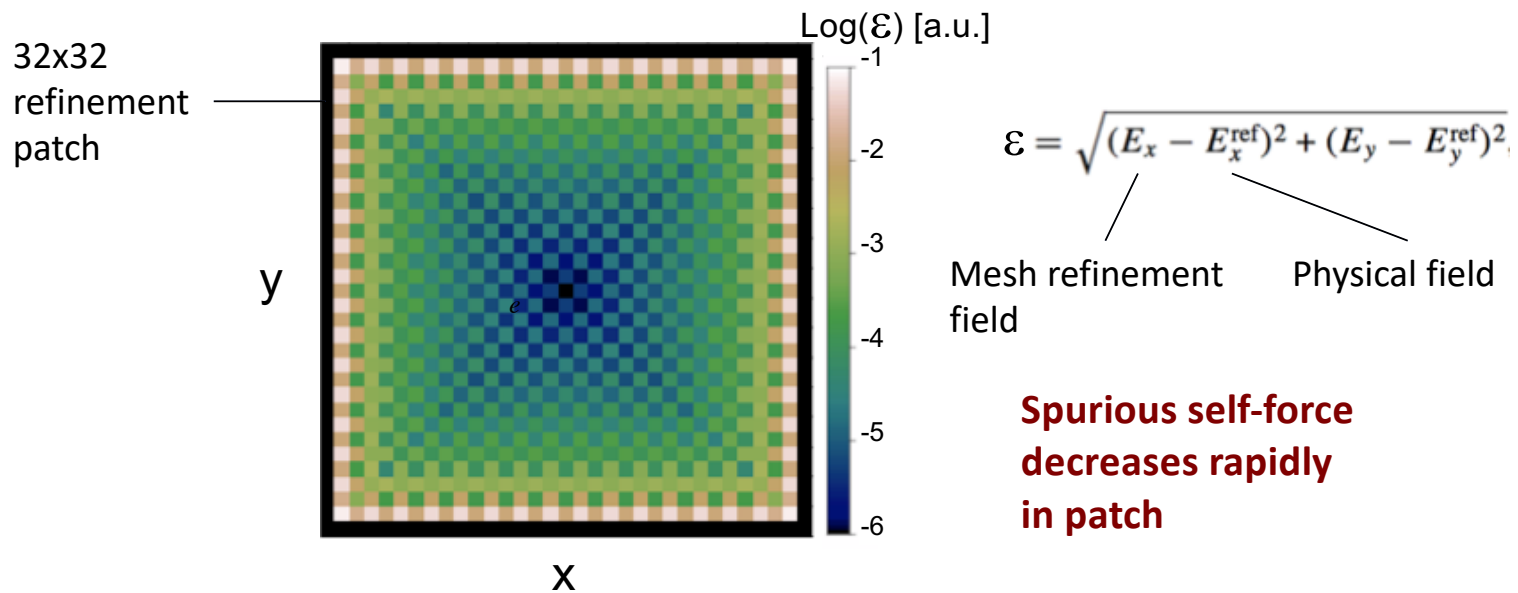
Now add a refinement patch.

→ Particle is trapped in patch by “spurious self-force”



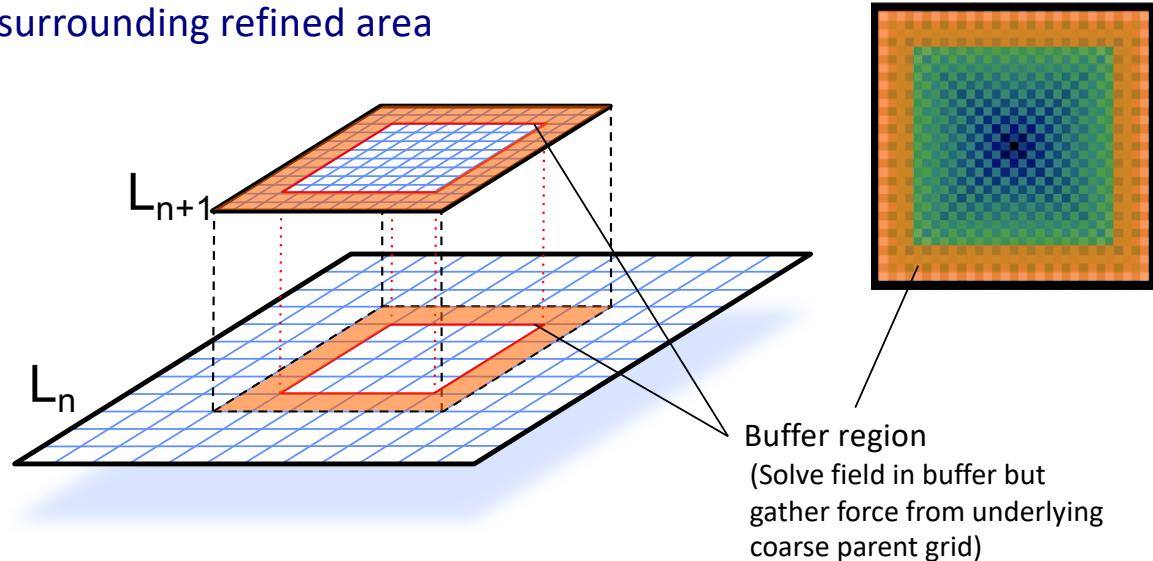
Spurious self-force: magnitude map

Map of spurious self-force as a function of particle position in refinement patch



Spurious self-force: mitigation

Add buffer region surrounding refined area



- 1 – solve on coarse grid,
- 2 – interpolate on fine grid boundaries,
- 3 – solve on fine grid,
- 4 – **disregard fine grid solution close to edge when gathering force onto particles.**

Thickness of buffer region provides user control of relative magnitude of spurious force.

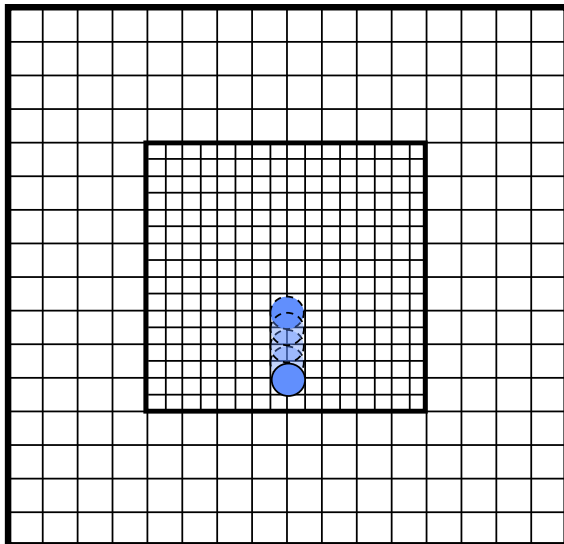


Spurious self-force: mitigation

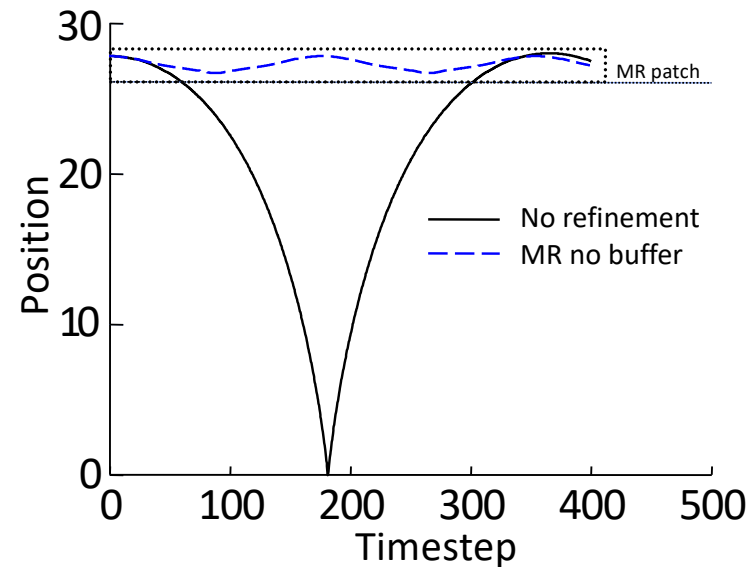
Test using script `test1partin1patch.py`:

- Run with `l_mr=1, ntransit=0`.

No buffer: particle trapped in patch.



Example with 2 and 4 guard cells buffer region

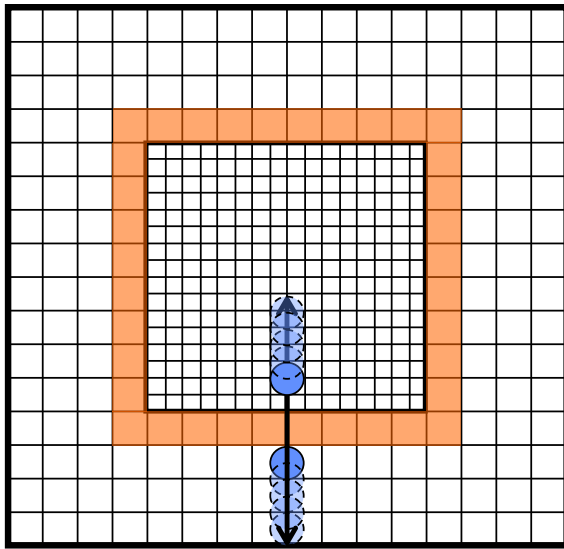


Spurious self-force: mitigation

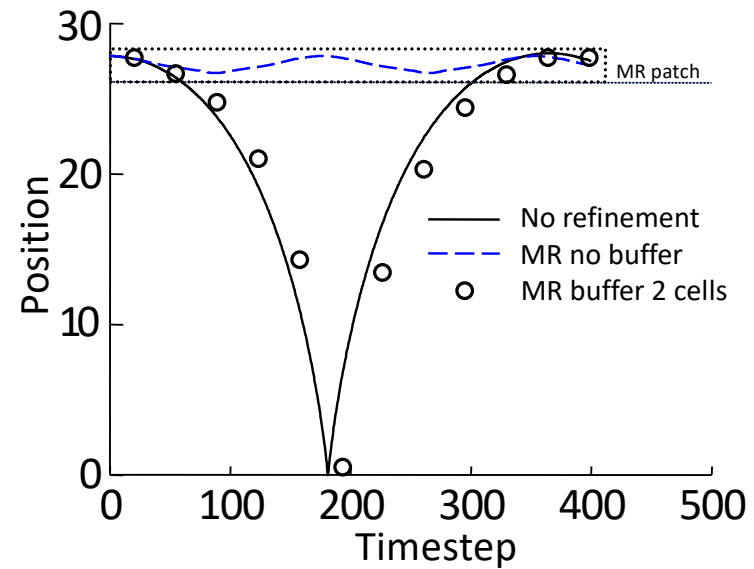
Test using script `test1partin1patch.py`:

- Run with `l_mr=1, ntransit=1`.

With buffer: no more trapping



Example with 2 and 4 guard cells buffer region

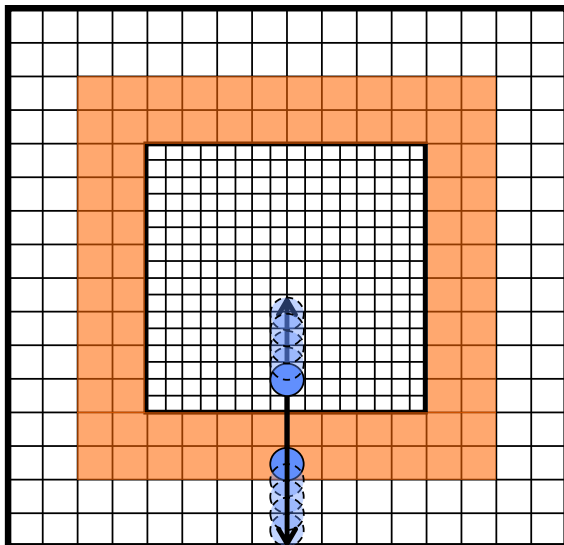


Spurious self-force: mitigation

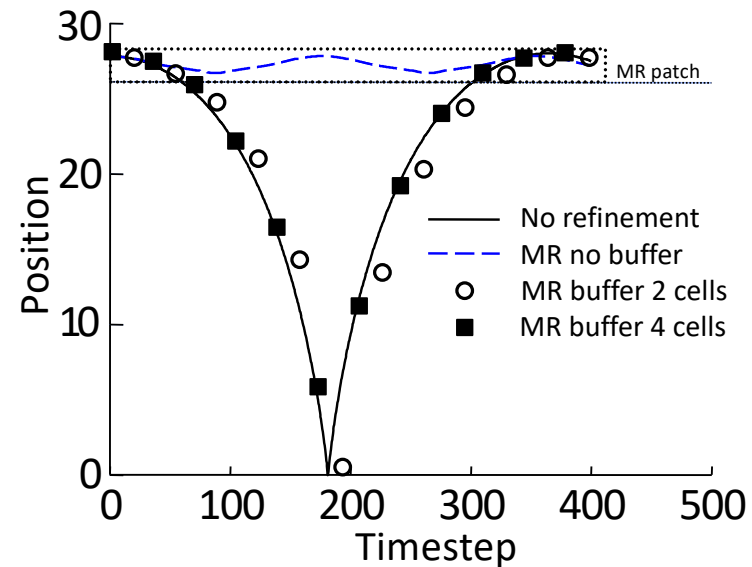
Test using script `test1partin1patch.py`:

- Run with `l_mr=1, ntransit=2`.

With buffer: no more trapping
4 guard cells better than 2



Example with 2 and 4
guard cells buffer region

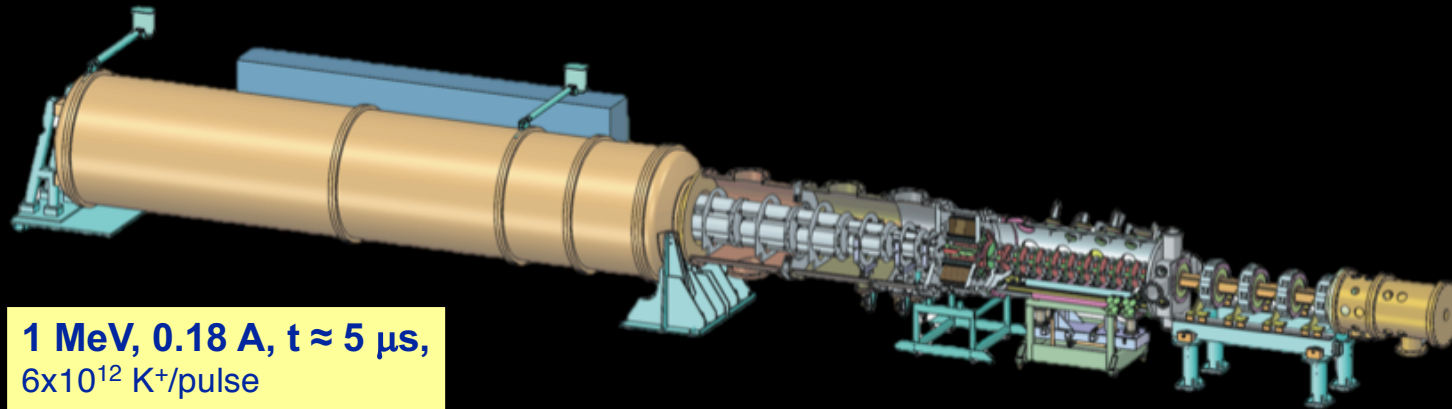


Buffer region is very effective.



Electrostatic AMR PIC example: HCX

High Current Experiment (High Brightness Beam Transport Campaign, 2005)



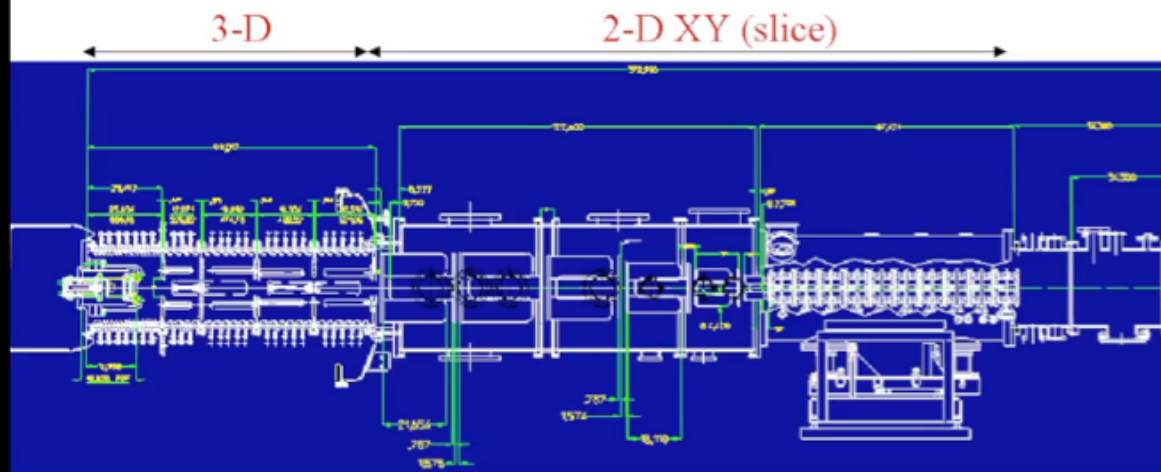
Heavy Ion Fusion program, LBNL

The Heavy Ion Fusion Virtual National Laboratory



Electrostatic AMR PIC example: HCX

WARP simulation of HCX

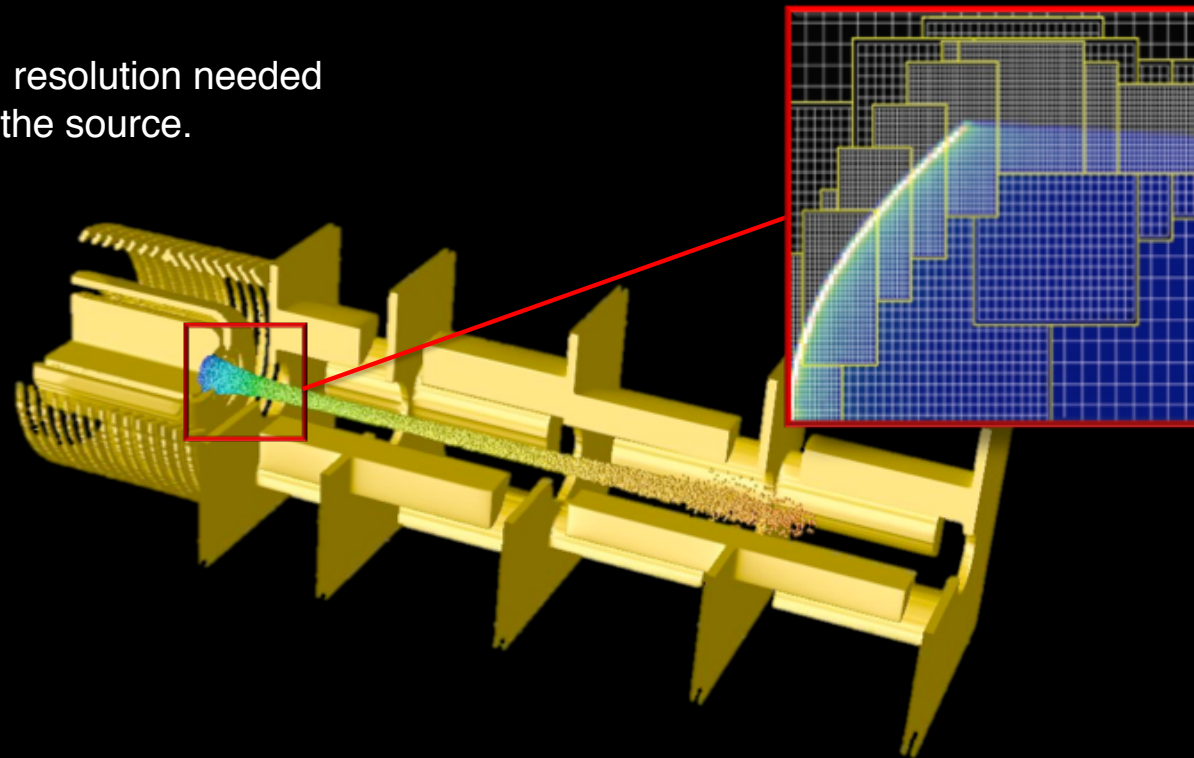


The Heavy Ion Fusion Virtual National Laboratory



Electrostatic AMR PIC example: HCX

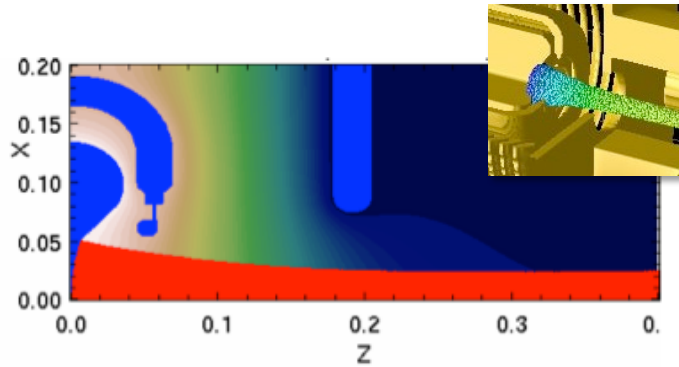
Very high resolution needed to model the source.



Source region is axisymmetric and is well captured with RZ simulations.

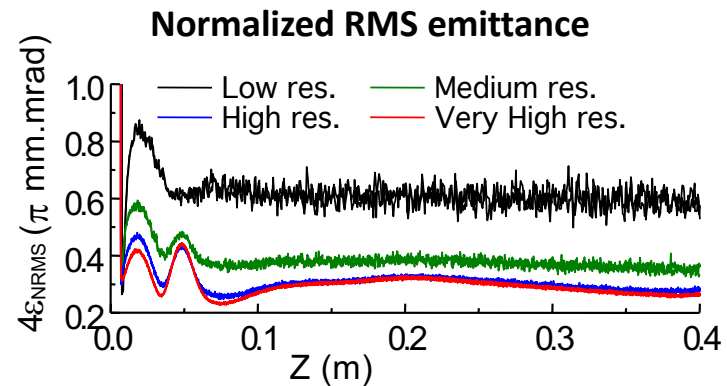
Modeling of source critical - determines initial shape of beam.

Axisymmetric (RZ) time-dependent simulations.

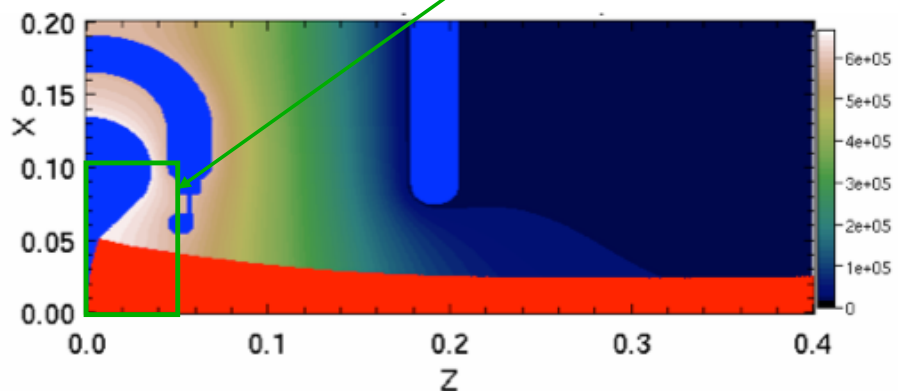


A fairly high resolution is needed to reach convergence

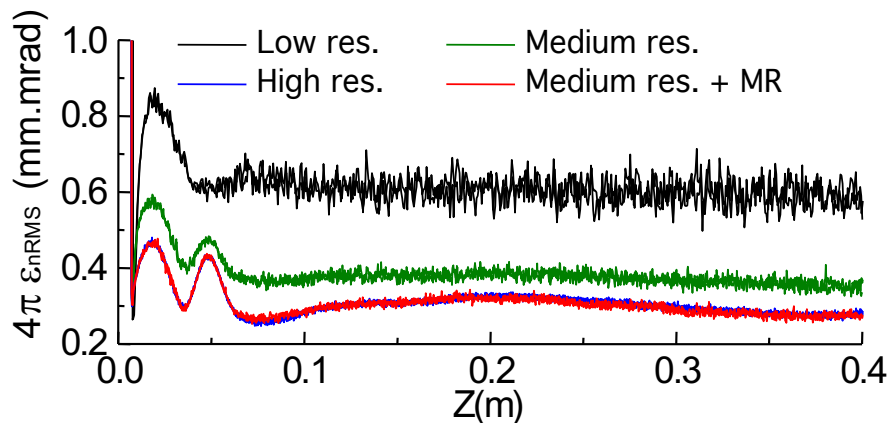
Run	Grid size	Nb particles
Low res.	56x640	~1M
Medium res.	112x1280	~4M
High res.	224x2560	~16M
Very High res.	448x5120	~64M



First MR attempt - 1 MR block surrounding emitter.



Refining around the emitter area is enough to recover emittance from converged high-resolution case.

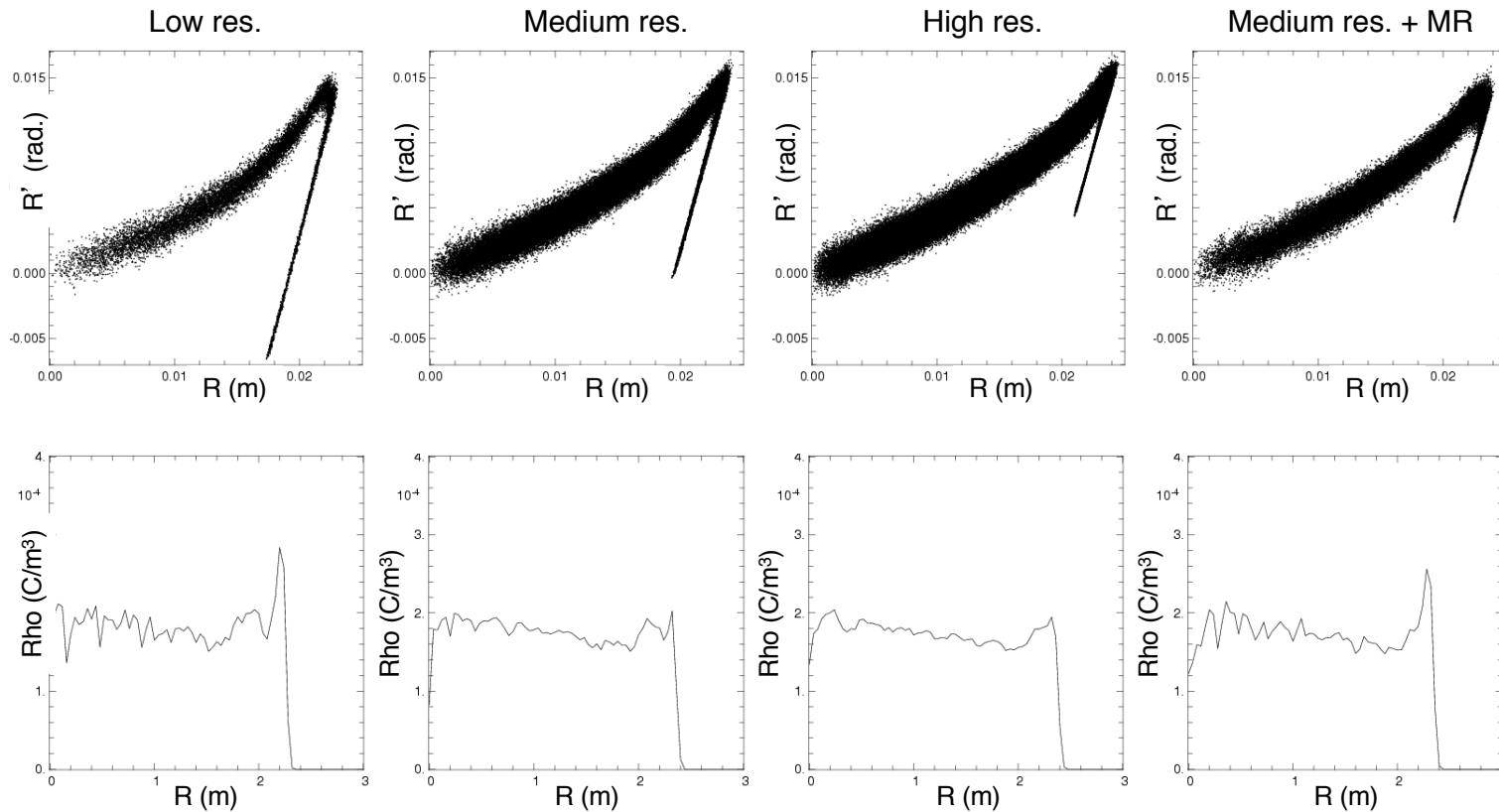


Run	Grid size	Nb particles
Low res.	56x640	~1M
Medium res.	112x1280	~4M
High res.	224x2560	~16M
Medium res. + MR	112x1280	~4M



First MR attempt - 1 MR block surrounding emitter (2).

However, it is not enough for recovering details of distribution.



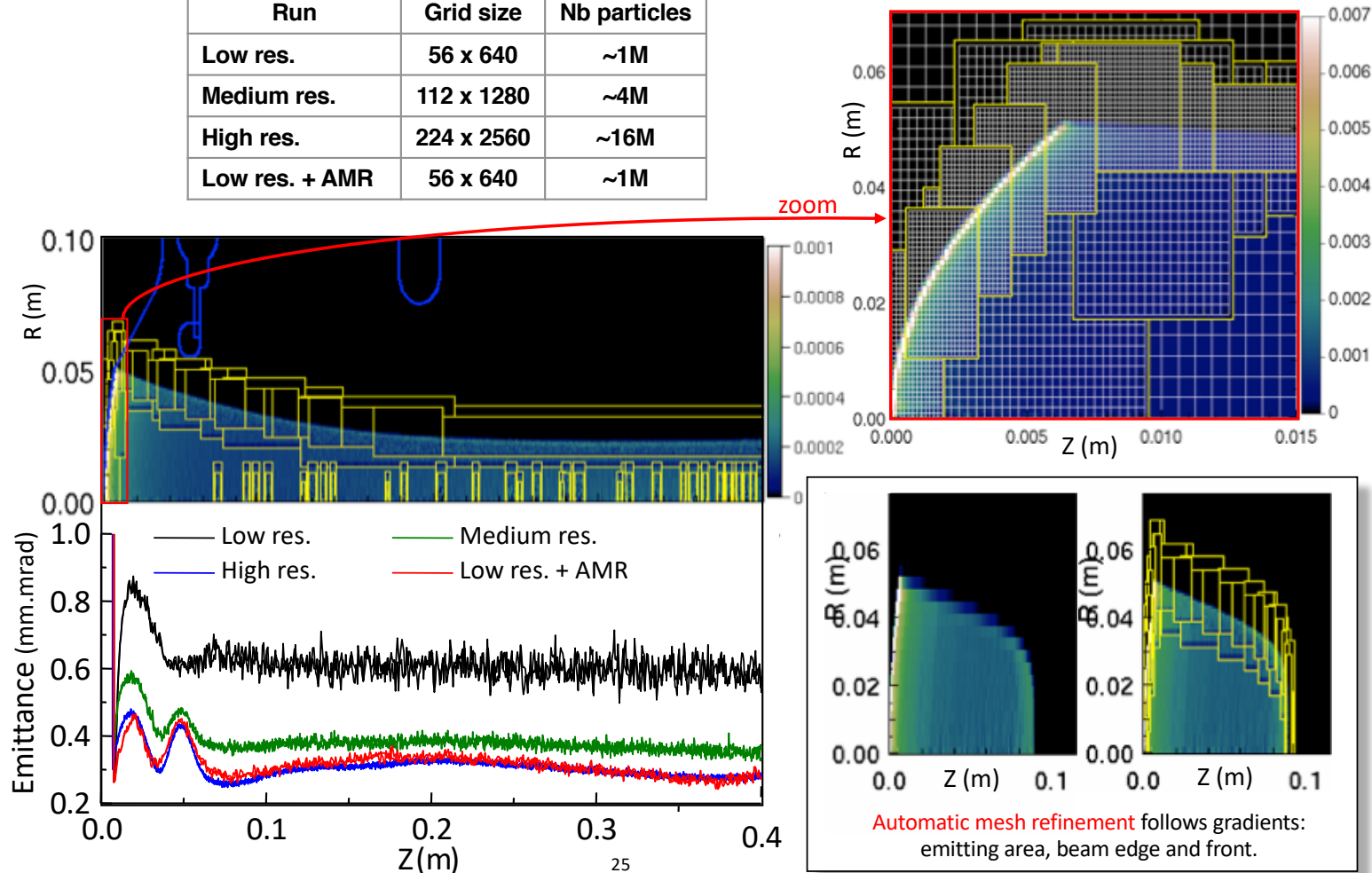
(plots from data at $z=0.4\text{m}$)



Full adaptive mesh refinement implementation

--speedup from AMR: x10

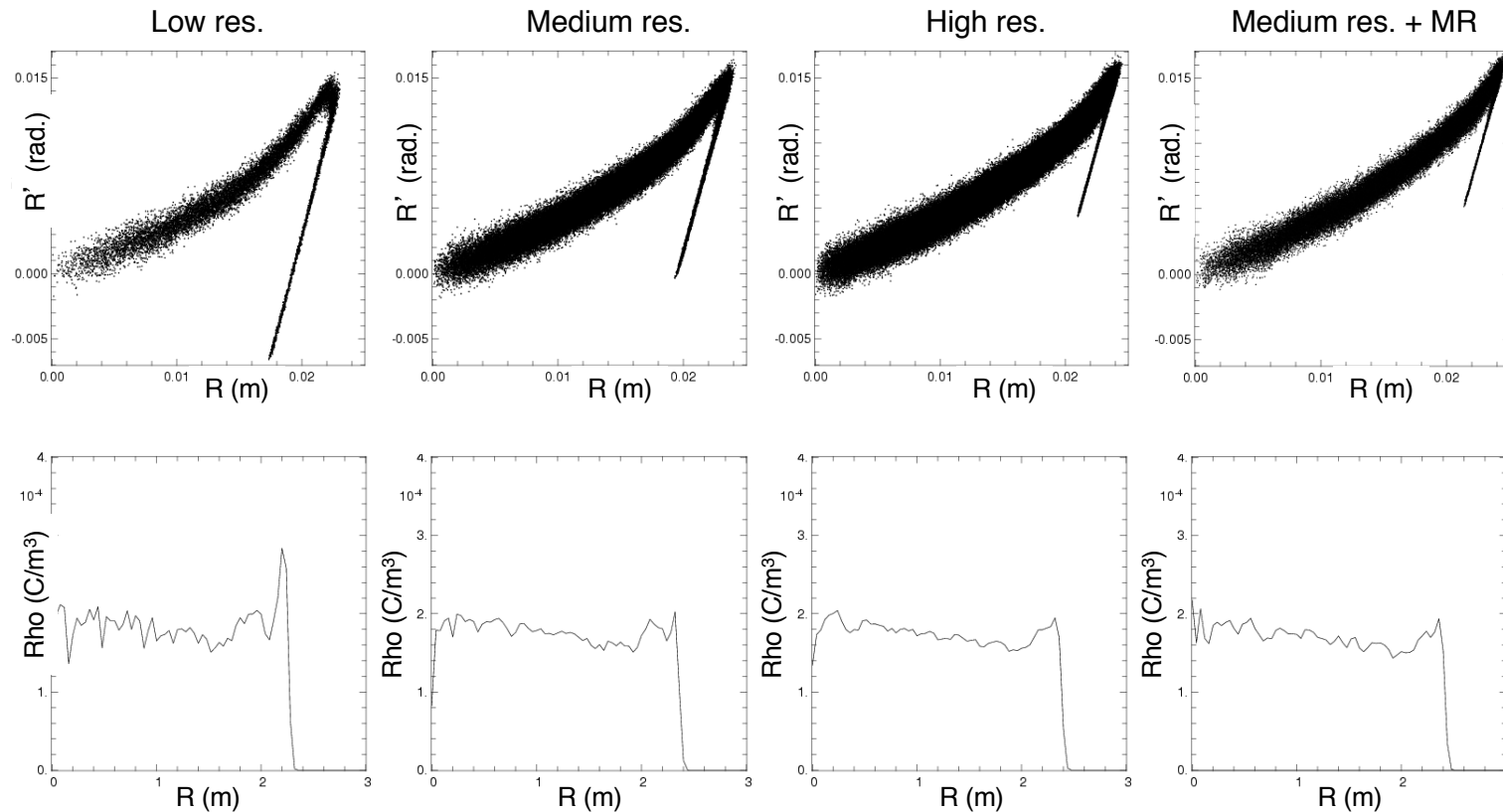
Run	Grid size	Nb particles
Low res.	56 x 640	~1M
Medium res.	112 x 1280	~4M
High res.	224 x 2560	~16M
Low res. + AMR	56 x 640	~1M



Full adaptive mesh refinement implementation

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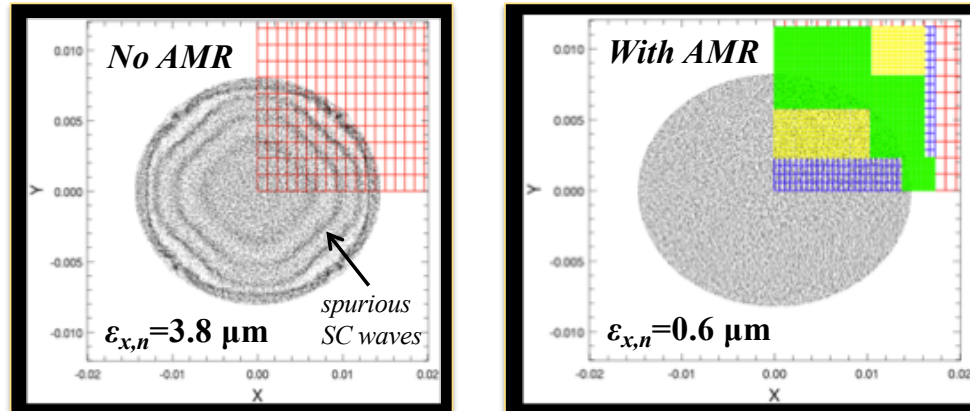
Full AMR enable recovery of details of distribution.



(plots from data at $z=0.4m$)



Example of AMR at edge of beam



Test using script `testxy_amr.py`:

- Run with `case='lowres'`, then `'highres'` and `'AMR'`.
- Observe how using AMR enables accurate simulation at reduced CPU cost.



Summary of electrostatic AMR-PIC

- Simple method for electrostatic AMR-PIC was presented.
- Buffer region mitigates spurious self-force effect very effectively.
- Speedups of x10 demonstrated on simulation of injector.
- Alternate methods such as multipole expansions have other advantages & drawbacks.



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1-D FDTD EM wave equation

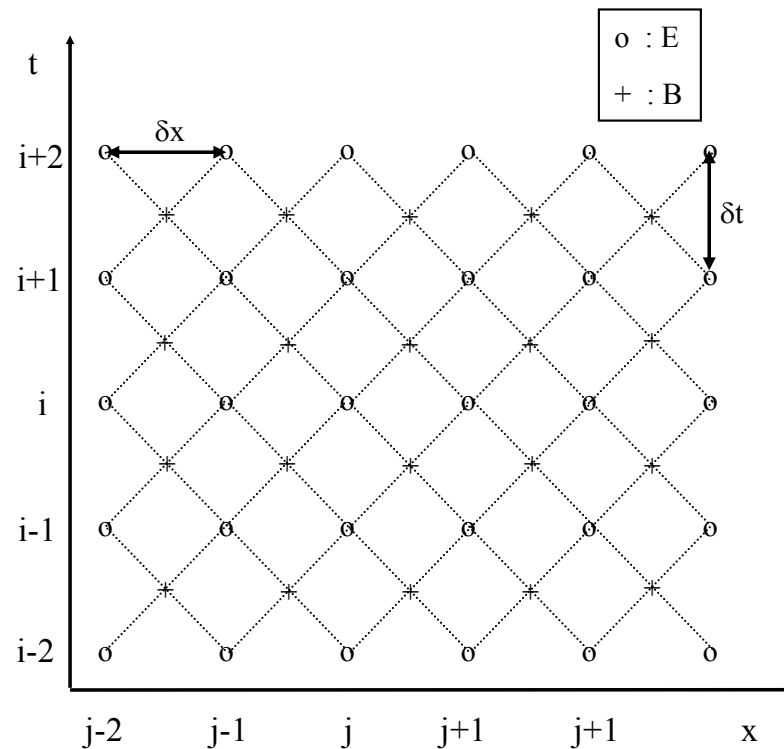
- We consider 1d wave equation (natural units)

$$\frac{\partial E}{\partial t} = \frac{\partial B}{\partial x}; \quad \frac{\partial B}{\partial t} = -\frac{\partial E}{\partial x}$$

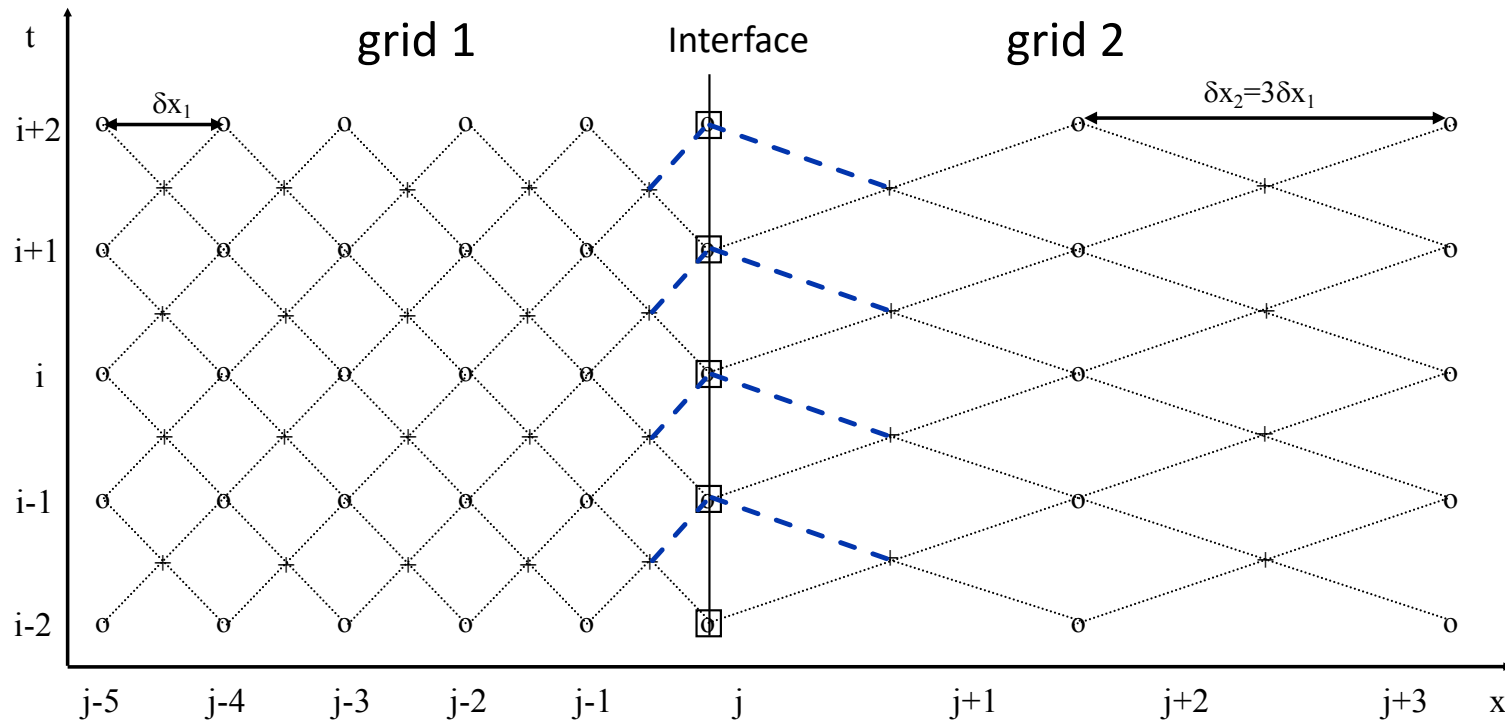
- staggered on a regular space time grid using finite-difference time-domain (FDTD) centered scheme

$$\frac{E_j^{i+1} - E_j^i}{\delta t} = \frac{B_{j+1/2}^{i+1/2} - B_{j-1/2}^{i+1/2}}{\delta x}$$

$$\frac{B_{j+1/2}^{i+1/2} - B_{j+1/2}^{i-1/2}}{\delta t} = -\frac{E_{j+1}^i - E_j^i}{\delta x}$$



1-D MR-EM: space refinement uncentered finite-difference



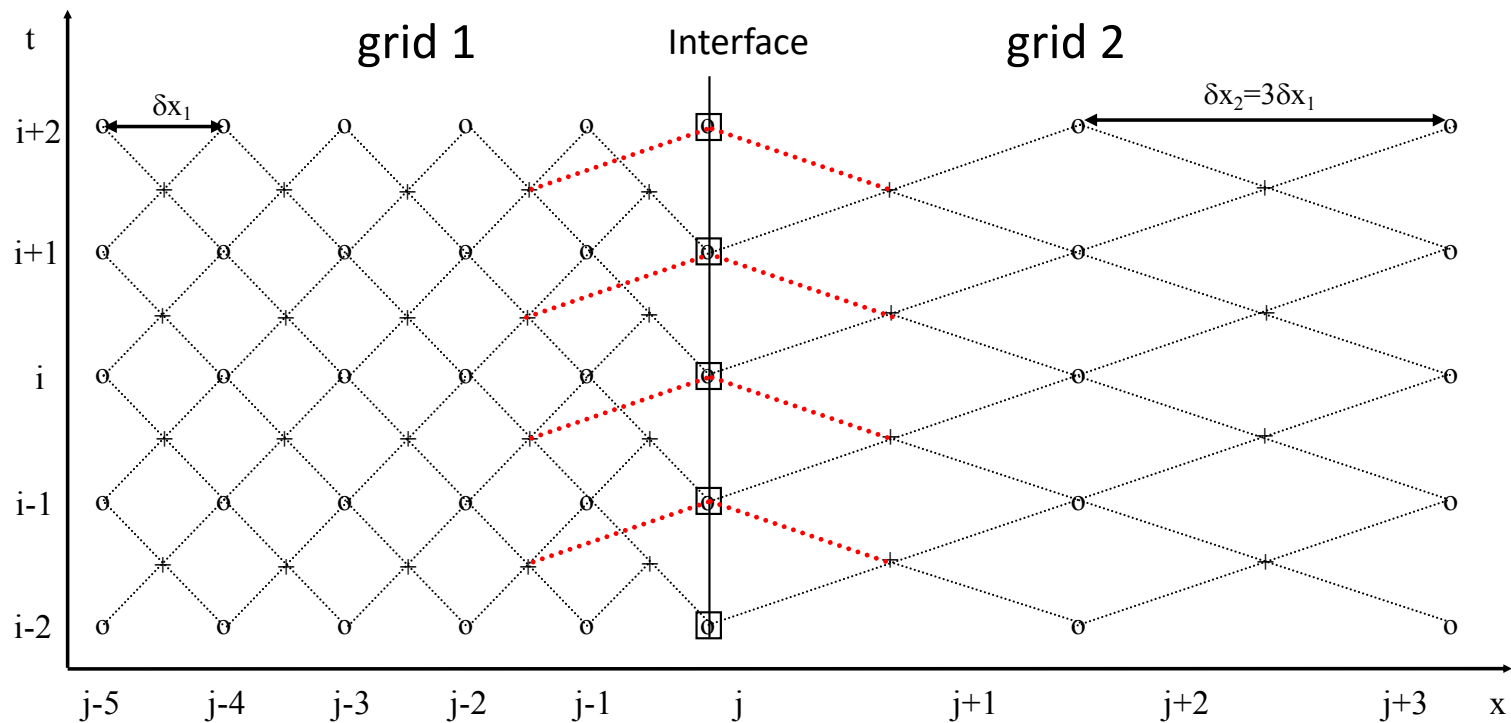
o, + : finite-difference at positions $\neq j$

□ : finite-volume (=uncentered FD) at j

$$\frac{E_j^{i+1} - E_j^i}{\delta t} = 2 \frac{B_{j+1/2}^{i+1/2} - B_{j-1/2}^{i+1/2}}{\delta x_1 + \delta x_2} \quad (\text{method 1})$$

$$\text{or} \quad \frac{E_j^{i+1} - E_j^i}{\delta t} = \frac{B_{j+1/2}^{i+1/2}}{\delta x_2} - \frac{B_{j-1/2}^{i+1/2}}{\delta x_1} \quad (\text{method 2})$$

1-D MR-EM: space refinement centered finite-difference



o, + : finite-difference at positions $\neq j$

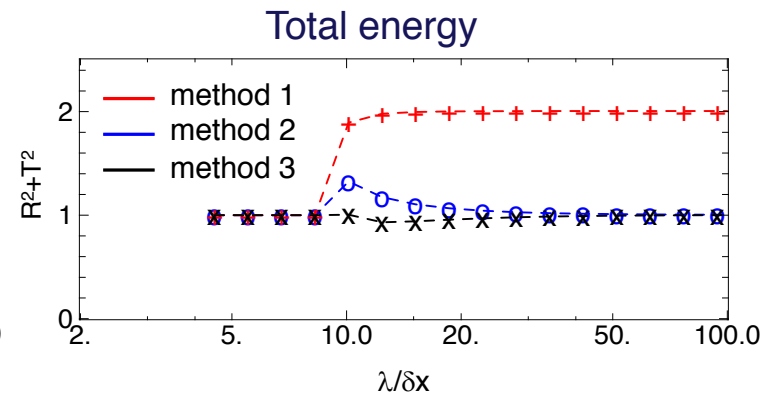
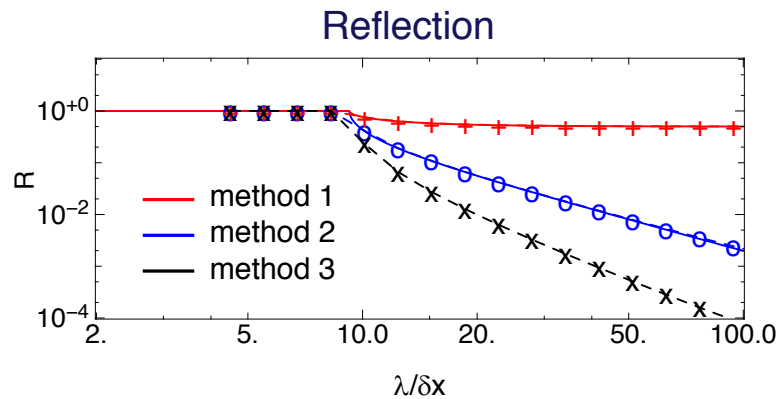
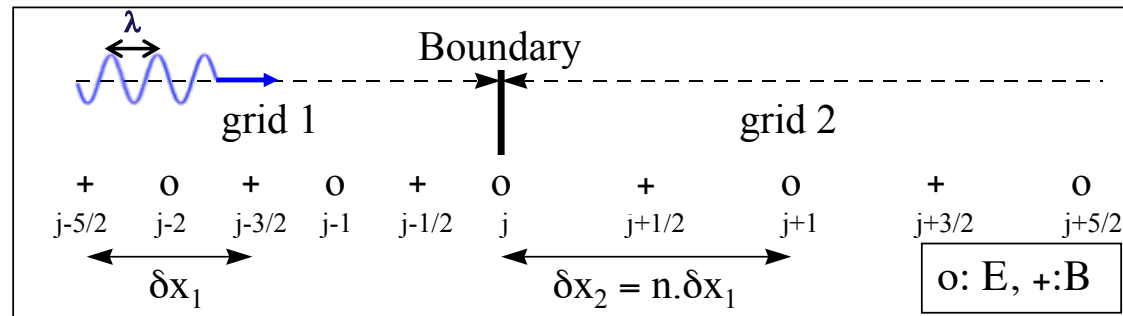
⊠ : 'jump' inside fine grid at j

$$\frac{E_j^{i+1} - E_j^i}{\delta t} = \frac{B_{j+1/2}^{i+1/2} - B_{j-1/2}^{i+1/2}}{\delta x_2} \quad (\text{method 3})$$



1-D MR-EM: coefficients of spurious reflection

Test to measure spurious reflection R at interface at j of signal injected on fine grid.

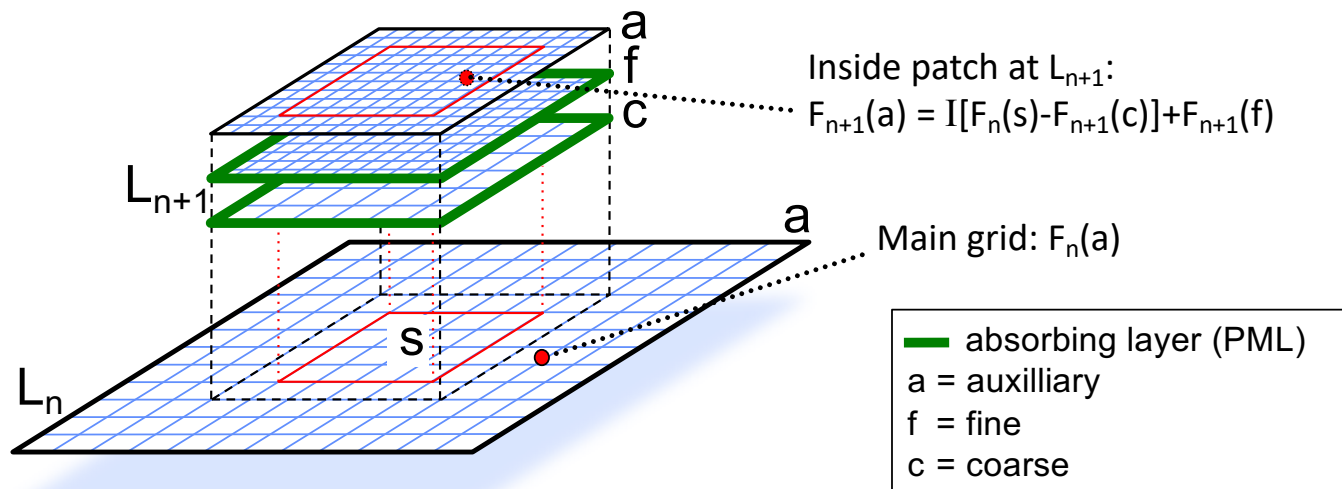


$\lambda \leq \lambda_{\text{Nyquist}}$ of coarse grid are reflected with amplification of total energy!



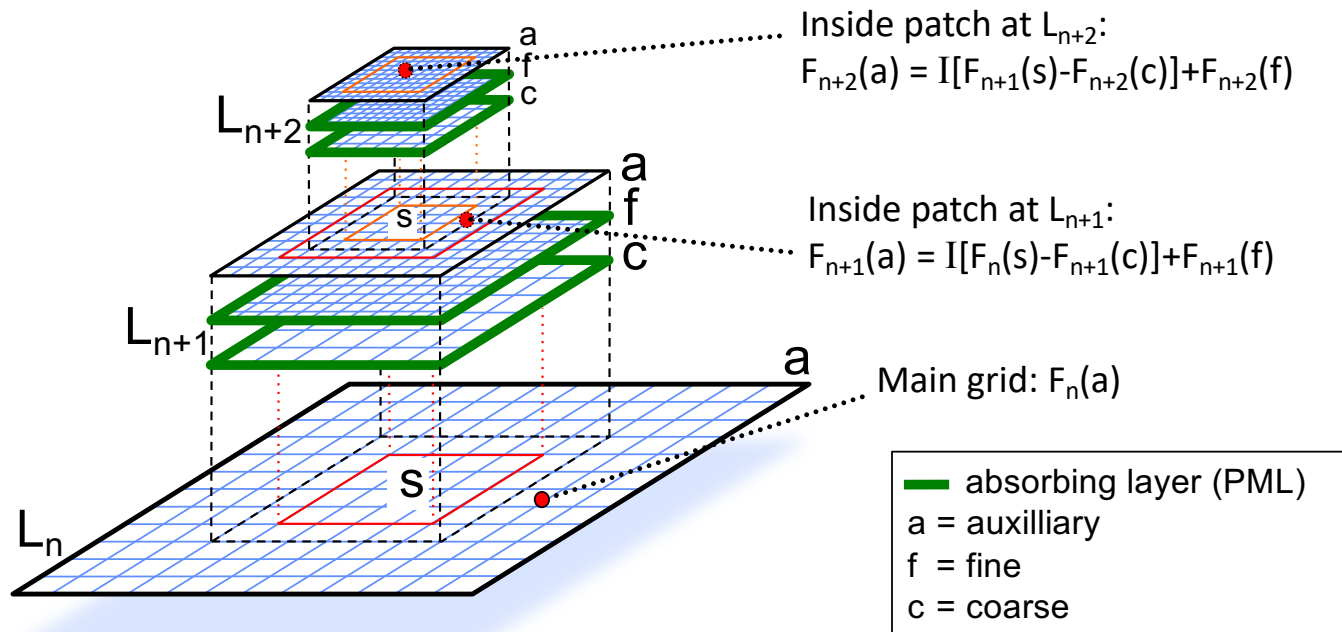
Warp & WarpX's Electromagnetic MR use PML and substitution to prevent reflections

- Termination of patches with Perfectly Matched Layers (PML) to avoid spurious reflections
- Buffer zone used for mitigating spurious self-force



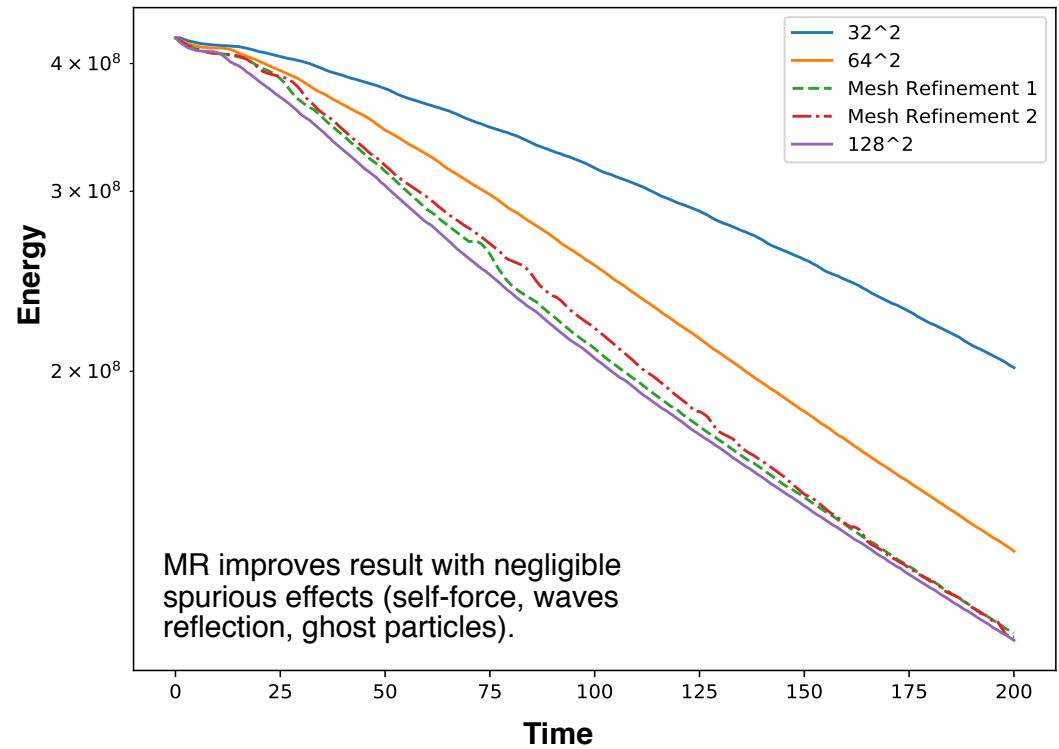
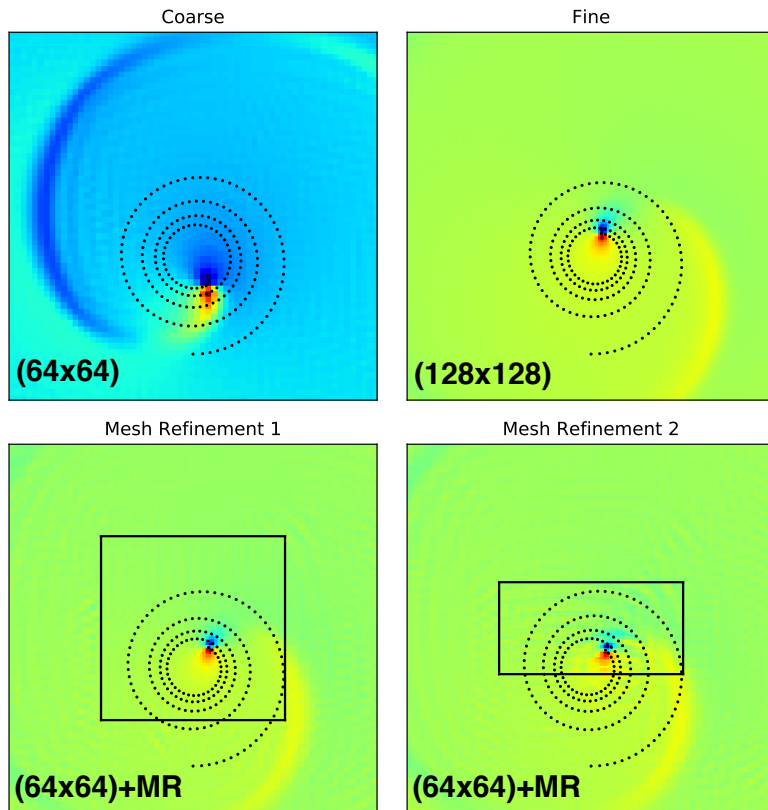
MR procedure is recursive, accommodating an arbitrary number of levels

Example with two levels of refinement



Test with single particle

Single particle orbiting around an external magnetic field, emitting synchrotron radiation



Note: buffer region not implemented yet; expected to improve results once implemented.



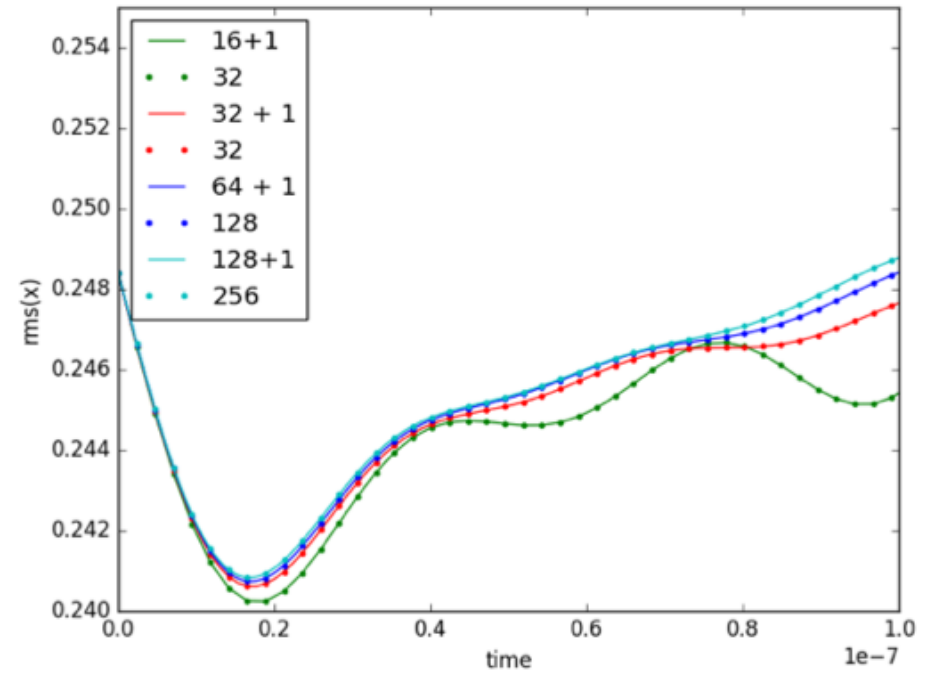
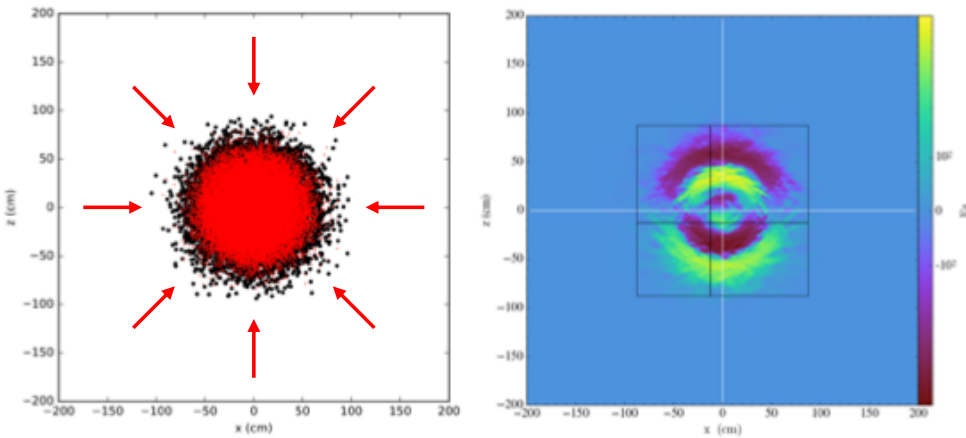
Validation on charged particle beam breathing

WarpX

Electron Gaussian distribution with inward initial radial velocity on top of static proton dist.

Electron beam contraction/expansion depends on resolution.

MR enables higher accuracy, covering fraction of box.

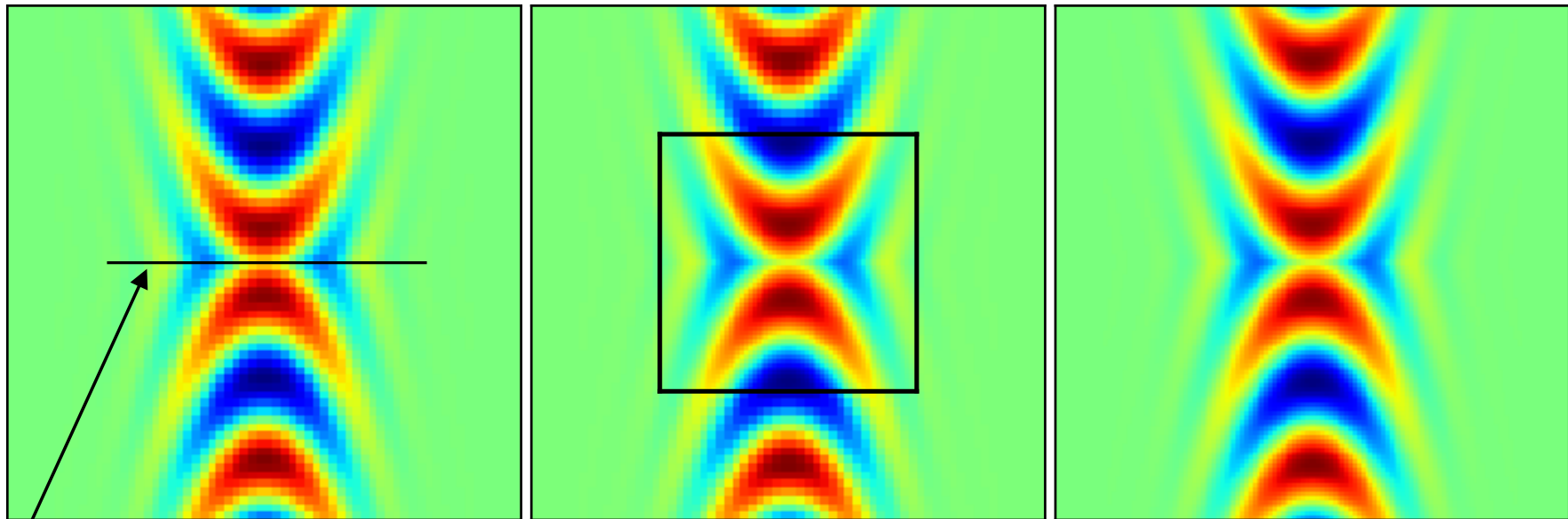


Laser injection with mesh refinement test

Coarse

Mesh Refinement

Fine

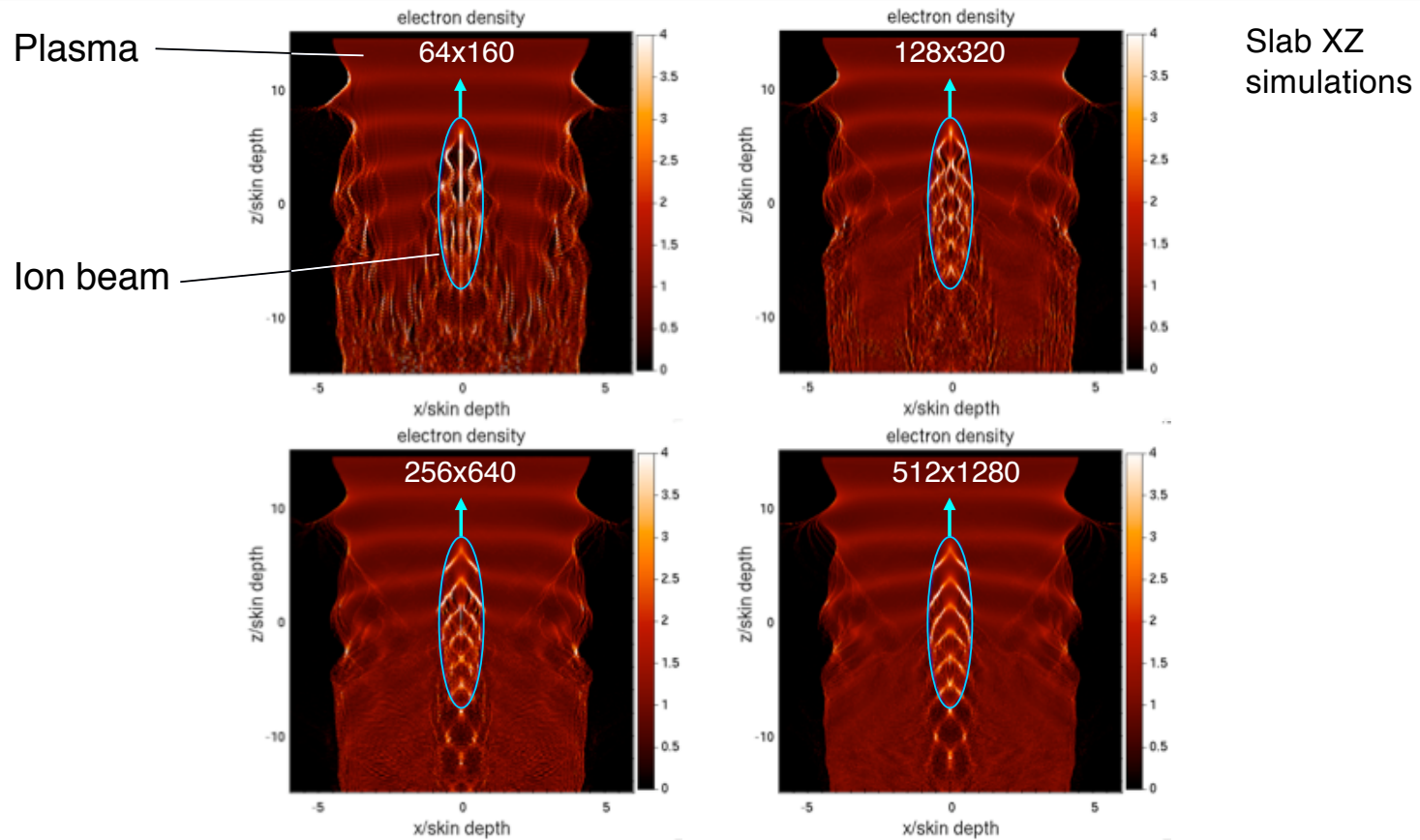


Laser generated with antenna.



Example: simulation of beam-induced plasma wake

Warp

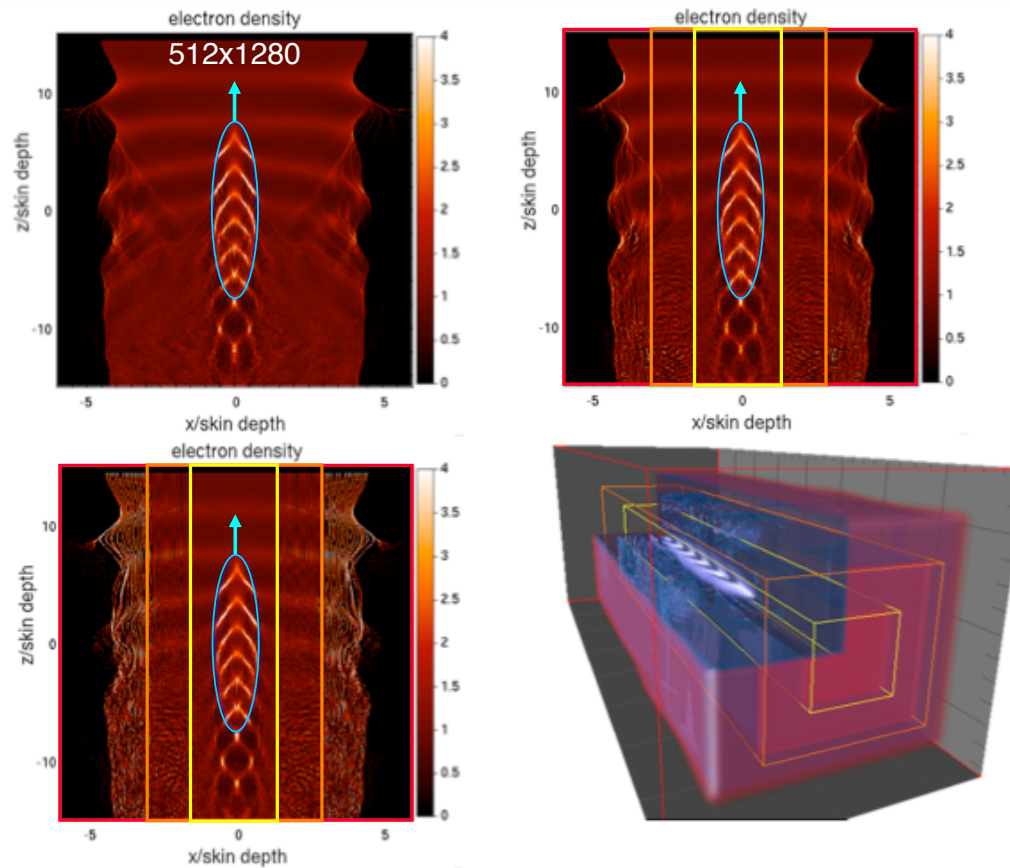


High resolution is needed to capture details.



Example: simulation of beam-induced plasma wake

Warp



Mesh ref.

- 2 levels
- fields only

low resolution
+ MR

- 2 levels
- fields+
particles

3-D

Speedup x10 in 3D (using the same time steps for all refinement levels).



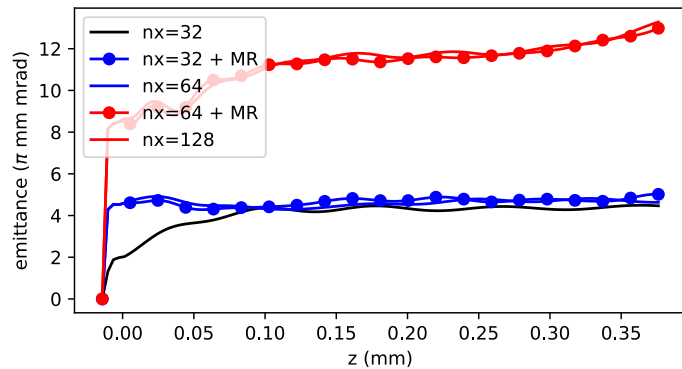
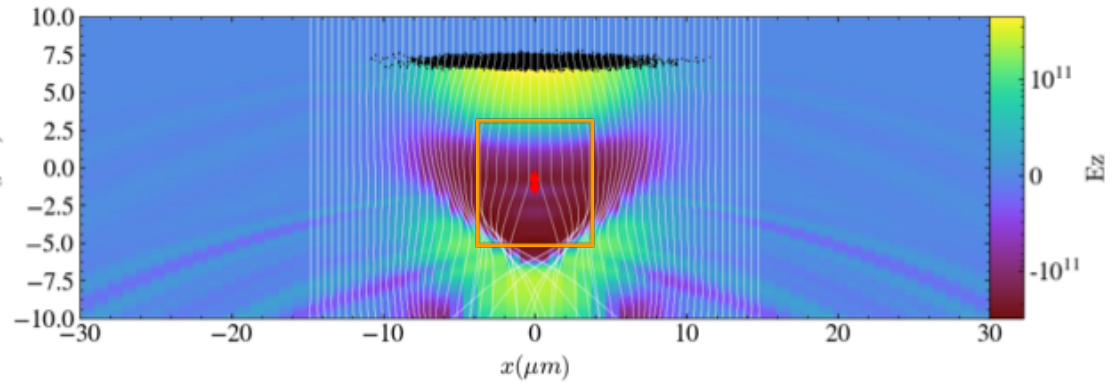
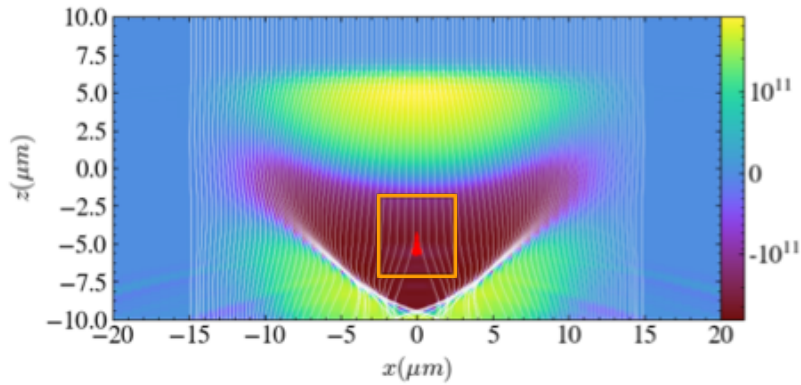
First simulations of plasma accelerators with MR patch – 2-D

WarpX

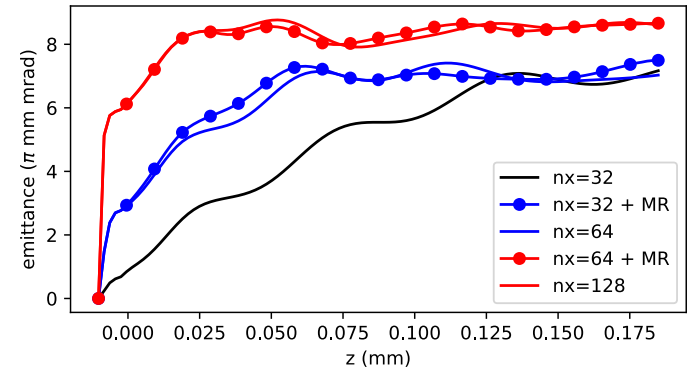
Laser driven

2-D

Particle beam driven



Simulations with small MR patch recover results using finer grid over the entire box.



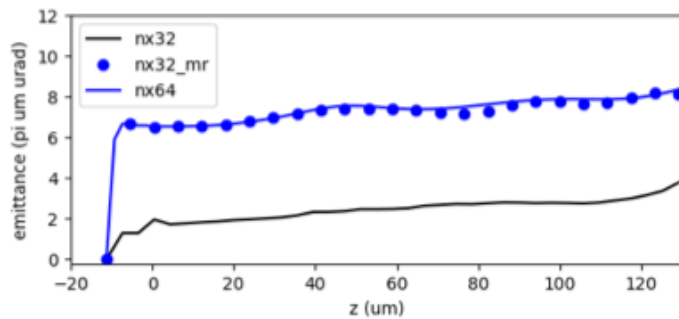
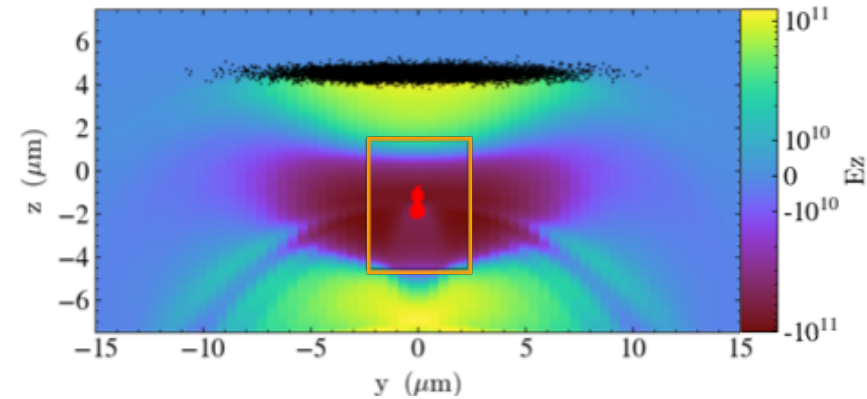
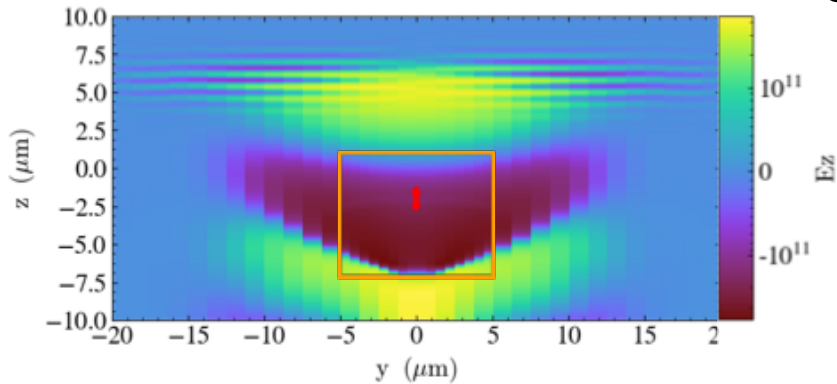
First simulations of plasma accelerators with MR patch – 3-D

WarpX

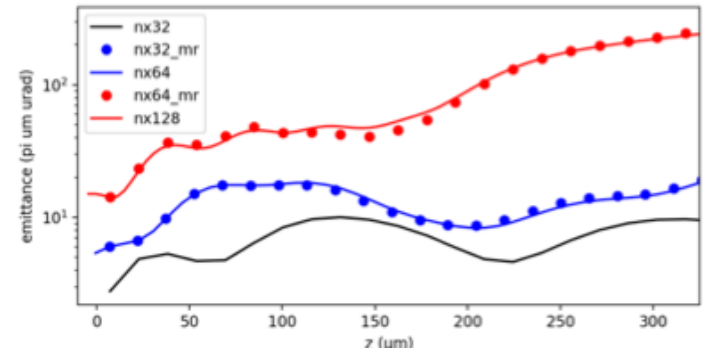
Laser driven

3-D

Particle beam driven

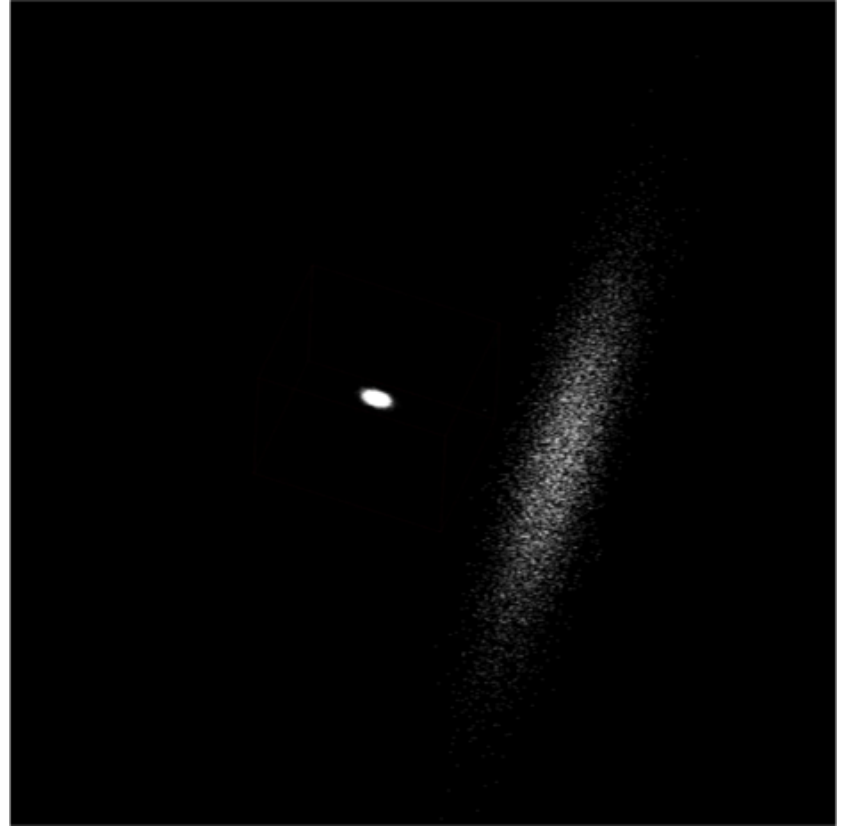
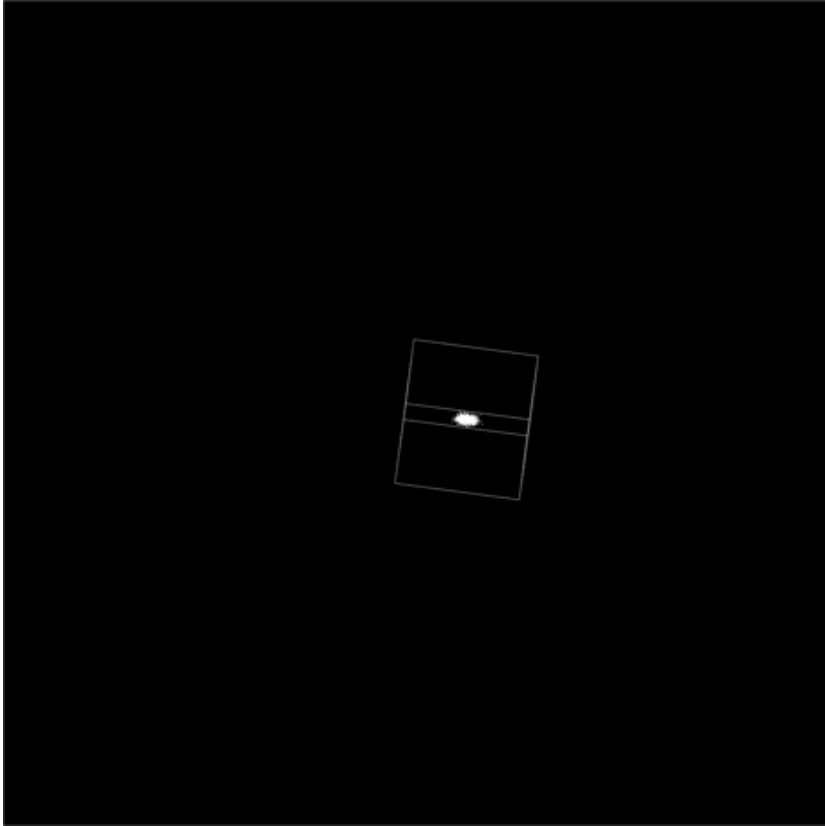


Simulations with small MR patch recover results using finer grid over the entire box.



Movies of 3D runs

WarpX



Movies by Maxence Thevenet

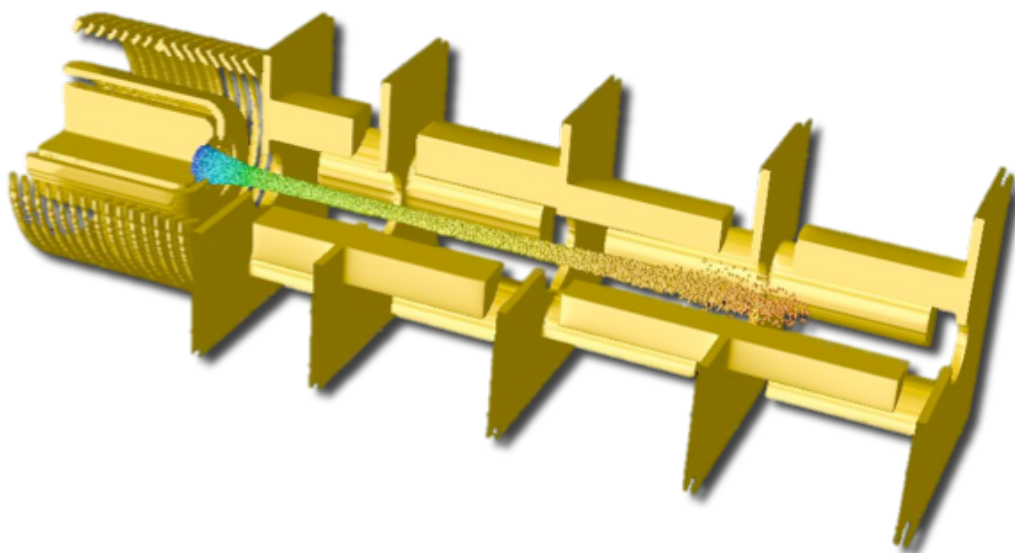


Outline

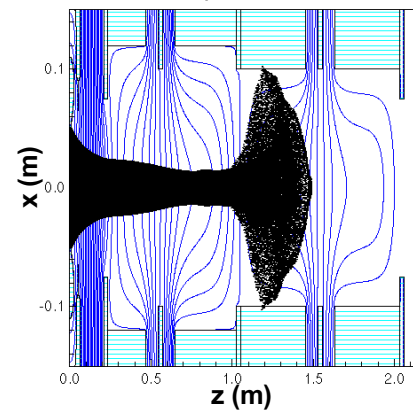
- Why mesh refinement?
- Potential issues
- Electrostatic mesh refinement
 - spurious self-force example
 - spurious self-force mitigation
 - application to the modeling of HCX injector
- Electromagnetic mesh refinement
 - spurious reflection of waves
 - spurious reflection of waves mitigation
 - Application to the modeling beam-induced plasma wake
- Special mesh refinement for particle emission
- Summary



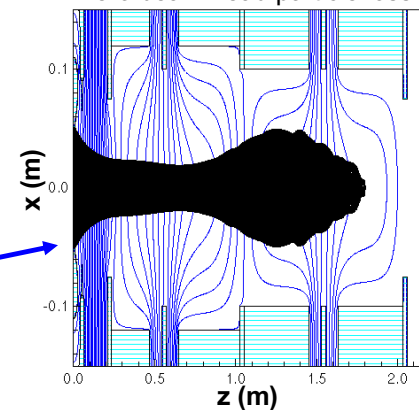
3-D WARP simulation of HCX showed beam head scrapping



beam head particle loss < 0.1%



Rise-time $\tau = 400$ ns
zero beam head particle loss

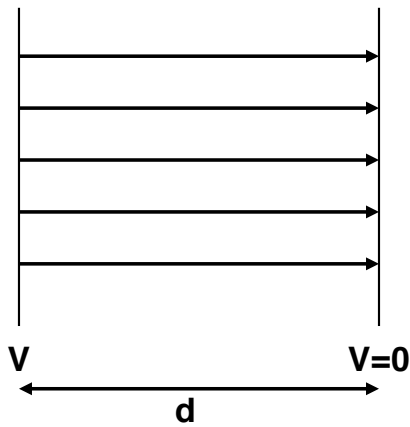


- Head cleaner with shorter voltage rise-time.
- Questions:
 - what is the optimal rise-time?
 - can we produce and model very-fast rise-time?

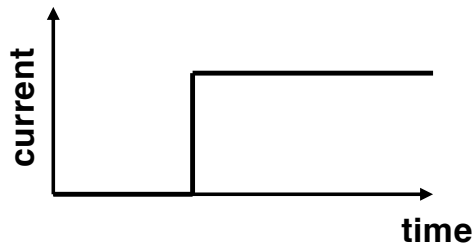


Test: 1-D time-dependent modeling of ion diode

Emitter Collector



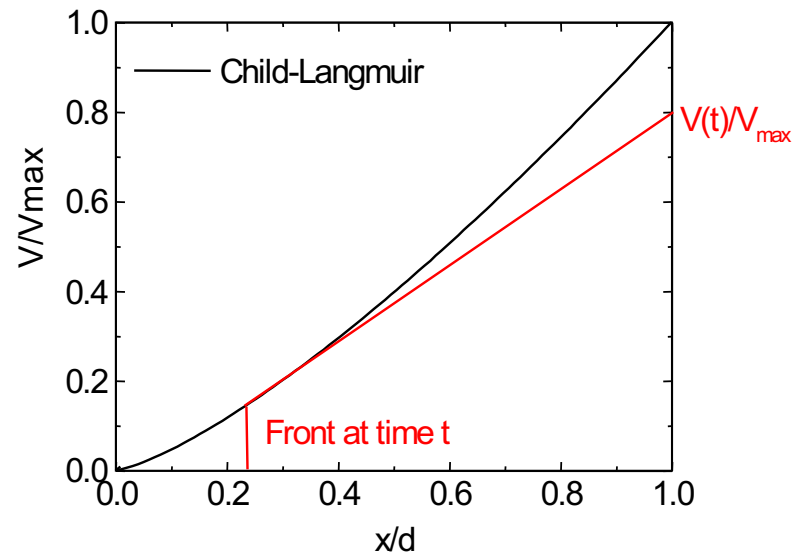
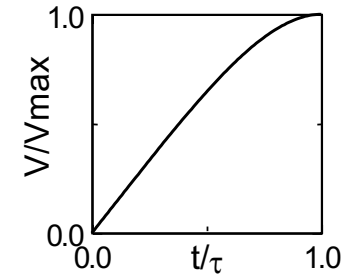
Applied voltage for Heavyside current history?



Analytic solution from Lampel-Tiefenback

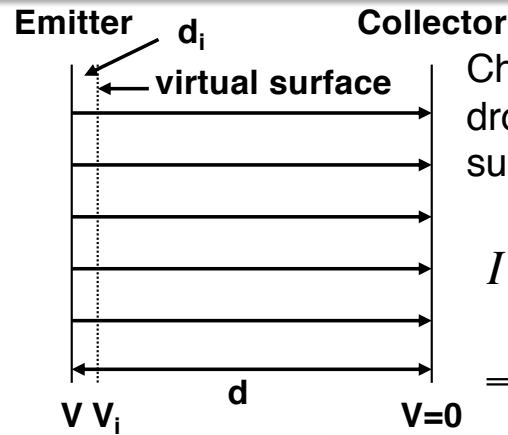
$$V(t) = \frac{t}{3\tau} \left[4 - \left(\frac{t}{\tau} \right)^3 \right] V_{\max}$$

(τ : transit time)



Test: 1D time-dependent modeling of ion diode (algo 1)

Injection algorithm

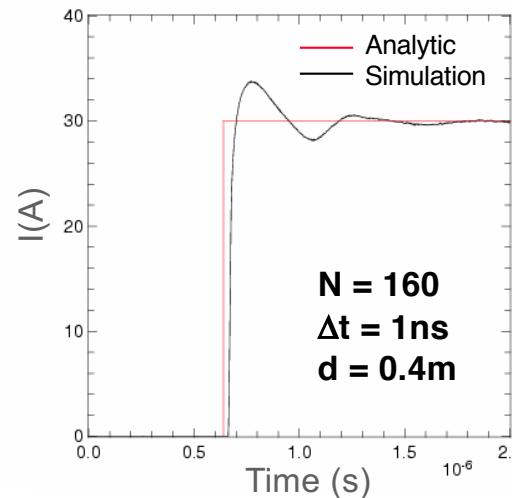
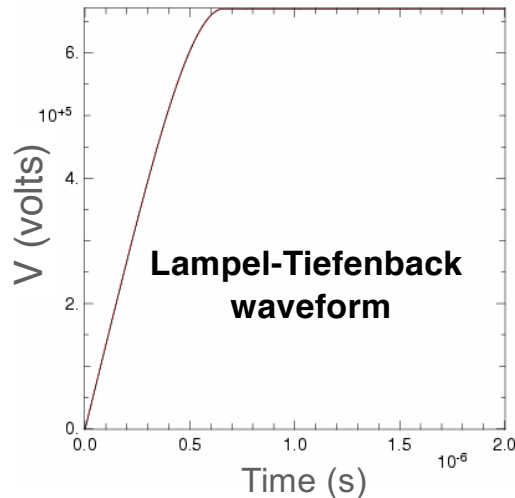


Child-Langmuir solution* + voltage drop between emitter and virtual surface determines current to inject.

$$I = \chi \frac{(V - V_i)^{3/2}}{d_i^2}; \quad \chi = \frac{4}{9} \epsilon_0 \sqrt{\frac{2q}{m}}$$

$$\Rightarrow \Delta Q = Nq = I\Delta t$$

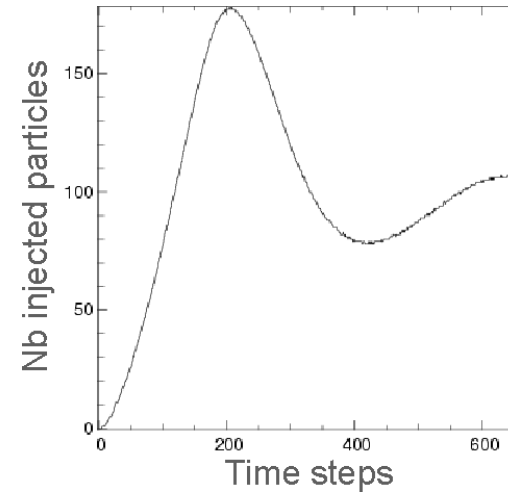
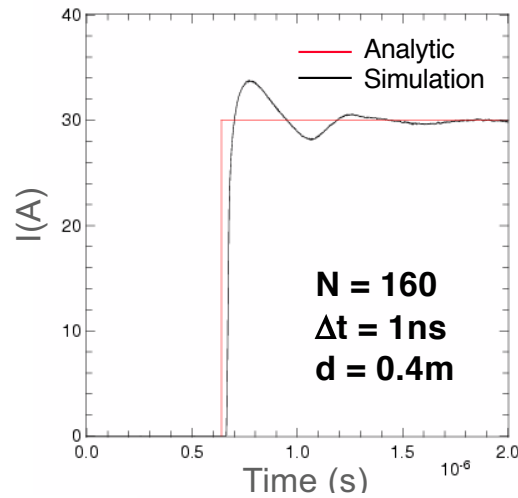
Result



Simulation result exhibits large unphysical oscillation.

*1-D; $\Rightarrow J \equiv I$ ($J=I/S$, $S=1$)

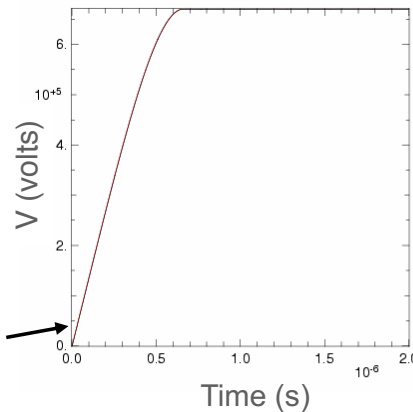
Unphysical oscillation related to Nb particles injected/time step (N_i)



Ideally,

$$\frac{N_i}{\Delta t} = \chi \frac{(V - V_i)^{3/2}}{qd_i^2} = Cste$$

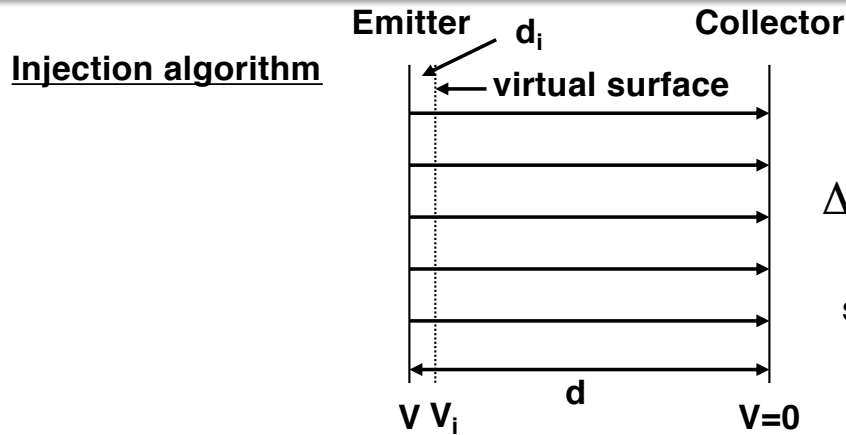
but the driving voltage is a continuous function derived analytically.



\Rightarrow Inconsistency due to infinitesimal solution applied in discrete world.



Cure: derive voltage history numerically



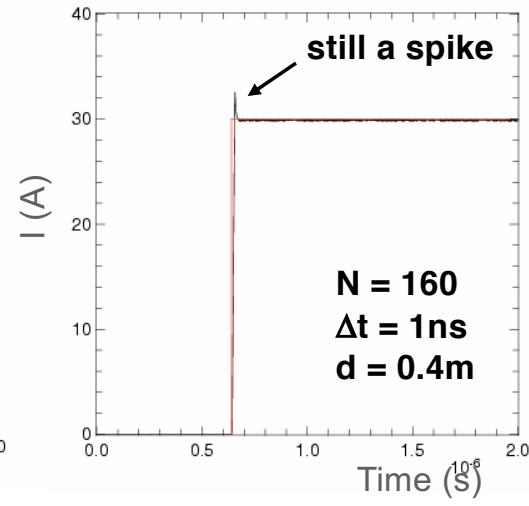
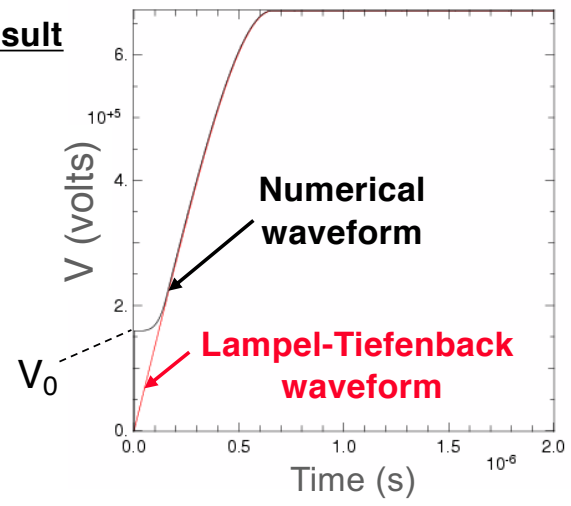
We apply Lampel-Tiefenback method at the discrete level

$$\Delta Q = Nq = I\Delta t \Rightarrow V - V_i = \left(\frac{Id_i^2}{\chi} \right)^{2/3}$$

solve for V using linearity of Poisson

$$(V-V_i) = (V-V_i)_{V=0} + (V-V_i)_{\rho=0}$$

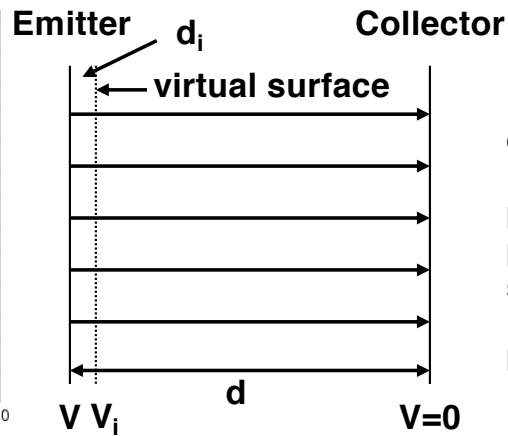
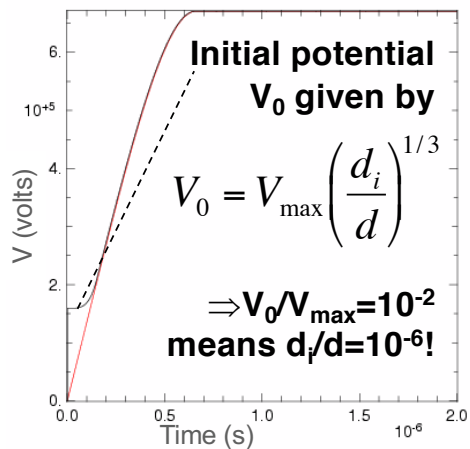
Result



Large unphysical oscillation has been suppressed but there is still a spike. Is it due to initial step V_0 in waveform?

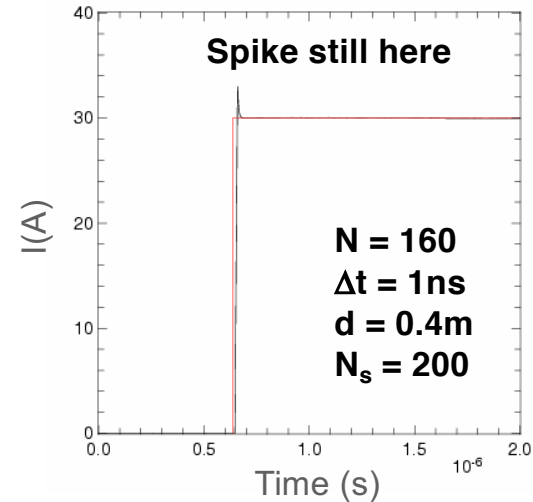
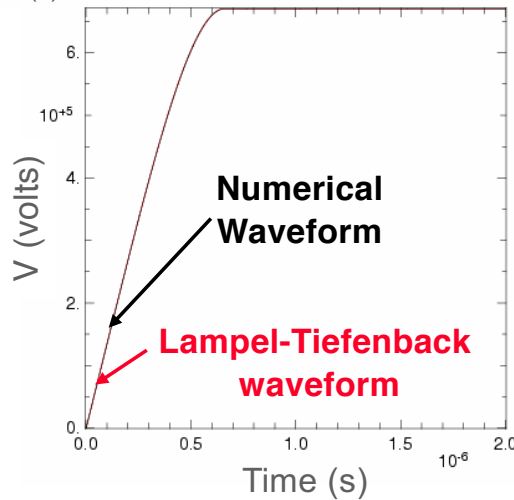


Cure #2: apply irregular gridded patch around emitter.



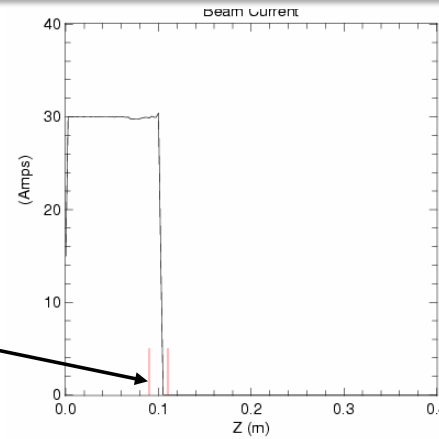
- Apply irregular gridded patch covering d_i
- Mesh sizes such that number of particles per cell is a constant in patch assuming Child-Langmuir solution for $\rho(z)$
- Apply same injection algorithm as before in patch

Result

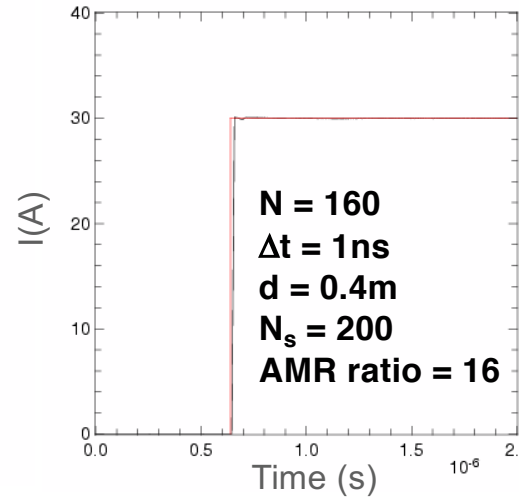
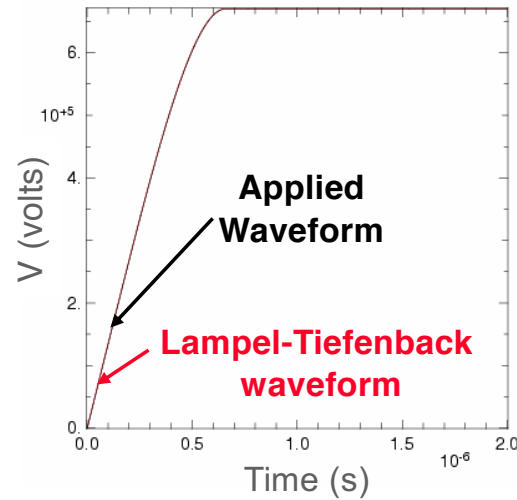


Cure #3: apply regularly gridded patch following front.

An Adaptive-Mesh-Refinement patch
Follows the front



Result

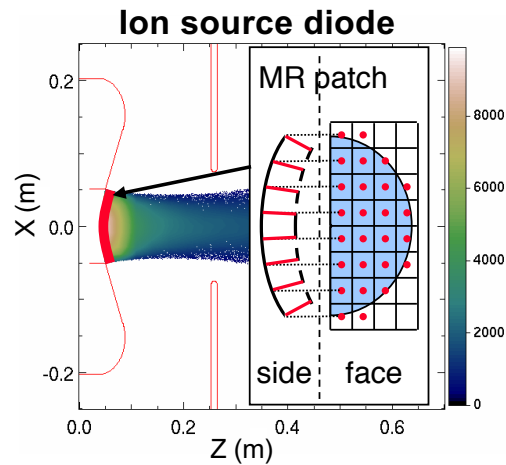


At this point,
we declared
victory!

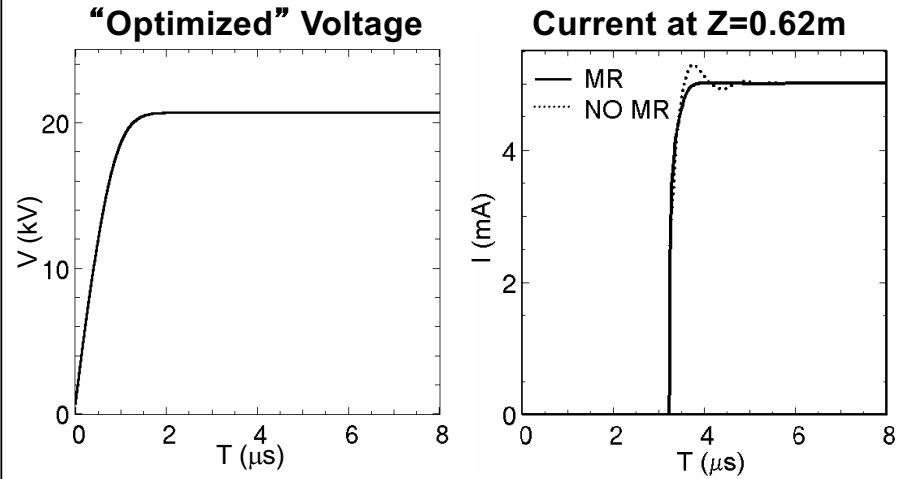


Extension to three dimensions

- Specialized 1-D patch implemented in 3-D injection routine, as a 2-D array of 1-D patches.



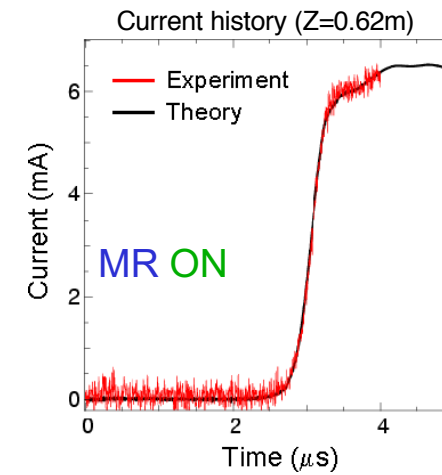
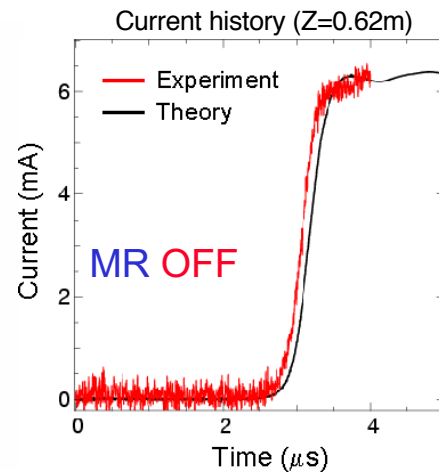
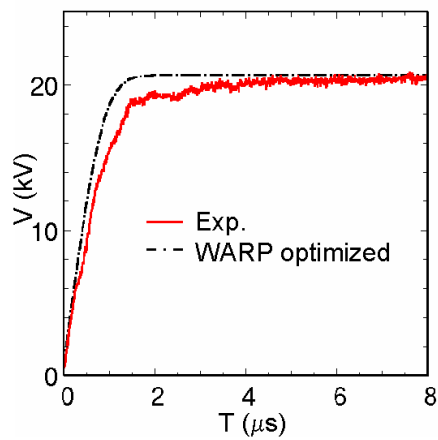
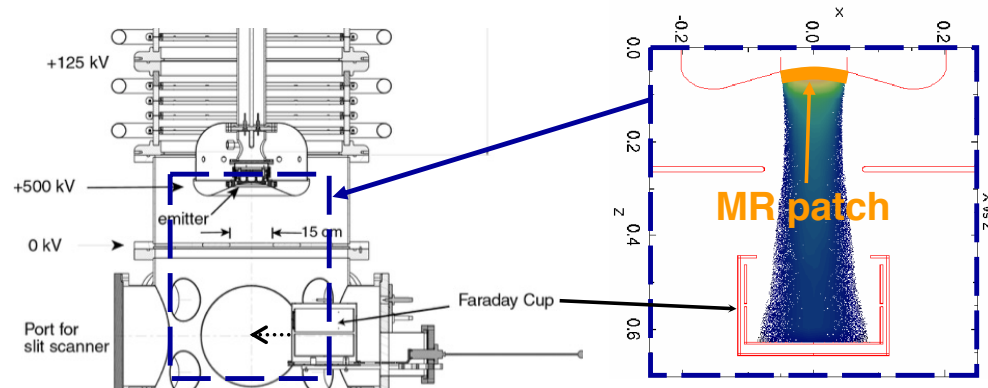
- Extended Lampel-Tiefenback technique to 3-D, and implemented in WARP
 - predicts a voltage waveform which extracts a nearly flat current at emitter



- Without MR, WARP predicts overshoot
- Run with MR predicts very sharp risetime (not square due to erosion)

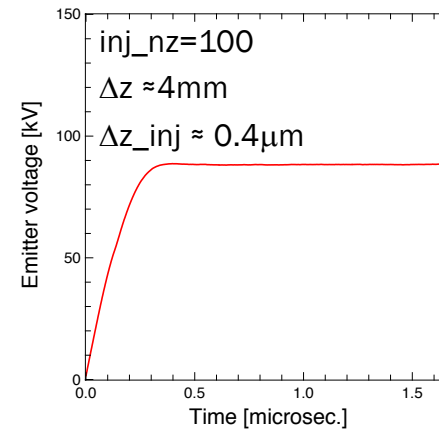
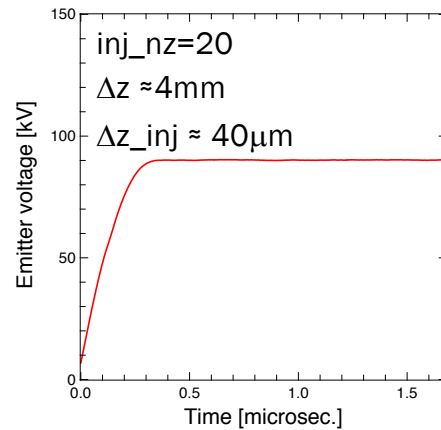
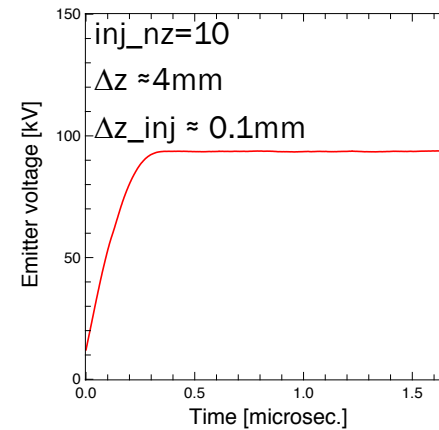
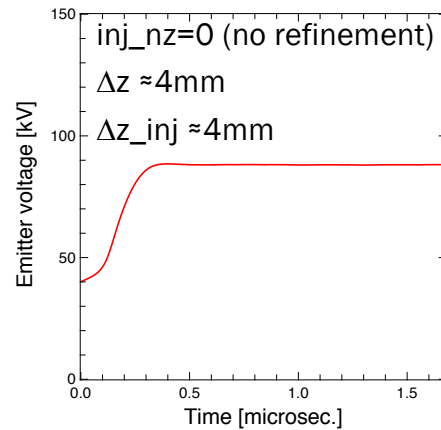


Test of MR patch on modeling of STS500 Experiment.



Pierce diode: exercise

- ① Open Pierce_diode_mrinj.py. Run with $w3d.inj_nz = 0, 10, 20$ and 100 .
- ② Observe convergence of voltage at $t=0$ toward 0 . Notice very small dz required!



AMR-PIC summary

- Mesh refinement (static or adaptive) can reduce simulation time by several.
- Care is needed to avoid spurious effects (spurious charge & reflections).
- Warp implementation has validated methods, but maintenance is lacking sufficient manpower:
 - ➔ To be used with great care by experience users.
 - ➔ Novel implementation with external AMR package (AMReX) is underway for AMR EM-PIC: WarpX.

References

1. J.-L. Vay, D. P. Grote, R. H. Cohen, & A. Friedman, “Novel methods in the Particle-In-Cell accelerator code-framework Warp”, *Computational Science & Discovery* **5**, 014019 (2012)
2. Vay, J.-L.; Friedman, A.; Grote, D.P; “Application of Adaptive Mesh Refinement to PIC Simulations in Inertial Fusion”, *Nuclear Inst. and Methods in Physics Research A* **544**, 347-352 (2005)
3. Vay J.-L., Colella P., Kwan JW., McCorquodale P., Serafini DB., Friedman A., Grote DP., Westenskow G., Adam JC., Heron A., Haber I., “Application of adaptive mesh refinement to particle-in-cell simulations of plasmas and beams” *Physics of Plasmas* **11**, 2928-2934 (2004)
4. Vay J.-L., Colella P, Friedman A, Grote DP, McCorquodale P, Serafini DB, “Implementations of mesh refinement schemes for particle-in-cell plasma simulations.”, *Comput. Phys. Comm.* **164**, 297-305 (2004)
5. Vay J.-L., Adam JC, Héron A, “Asymmetric PML for the absorption of waves. Application to mesh refinement in electromagnetic particle-in-cell plasma simulations.”, *Comput. Phys. Comm.* **164**, 171-177 (2004)

